



Data Sheet

#### Features

- 1024 channel x 1024 channel non-blocking digital Time Division Multiplex (TDM) switch at 4.096 Mbps, 8.192 Mbps and 16.384 Mbps or using a combination of ports running at 2.048 Mbps, 4.096 Mbps, 8.192 Mbps and 16.384 Mbps
- 16 serial TDM input, 16 serial TDM output streams
- Output streams can be configured as bidirectional for connection to backplanes
- Exceptional input clock cycle to cycle variation tolerance (20 ns for all rates)
- Per-stream input and output data rate conversion selection at 2.048 Mbps, 4.096 Mbps, 8.192 Mbps or 16.384 Mbps. Input and output data rates can differ
- Per-stream high impedance control outputs (STOHZ) for 8 output streams

#### July 2005

#### **Ordering Information**

ZL50016GAC 256 Ball PBGA Trays ZL50016QCC 256 Lead LQFP Trays -40°C to +85°C

- Per-stream input bit delay with flexible sampling point selection
- Per-stream output bit and fractional bit advancement
- Per-channel ITU-T G.711 PCM A-Law/ $\mu$ -Law Translation
- Input clock: 4.096 MHz, 8.192 MHz, 16.384 MHz
- Input frame pulses:61 ns, 122 ns, 244 ns
- · Four frame pulse and four reference clock outputs
- Three programmable delayed frame pulse outputs

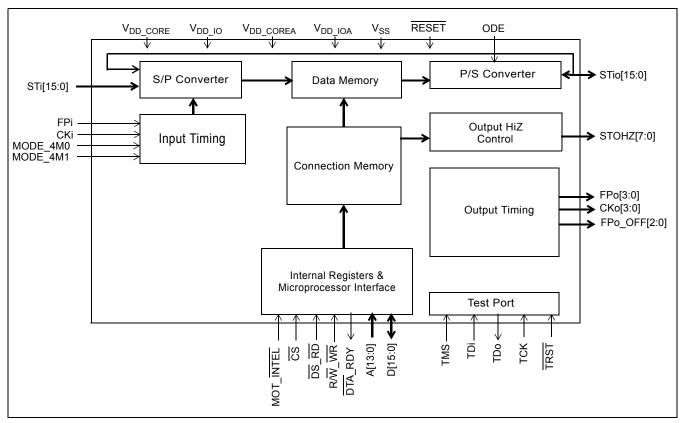


Figure 1 - ZL50016 Functional Block Diagram

1

- Per-channel constant or variable throughput delay for frame integrity and low latency applications
- Per Stream (16) Bit Error Rate Test circuits complying to ITU-0.151
- Per-channel high impedance output control
- Per-channel message mode
- Control interface compatible with Intel and Motorola 16-bit non-multiplexed buses
- Connection memory block programming
- Supports ST-BUS and GCI-Bus standards for input and output timing
- IEEE-1149.1 (JTAG) test port
- 3.3 V I/O with 5 V tolerant inputs; 1.8 V core voltage

# Applications

- PBX and IP-PBX
- Small and medium digital switching platforms
- Remote access servers and concentrators
- Wireless base stations and controllers
- Multi service access platforms
- Digital Loop Carriers
- Computer Telephony Integration

# Description

The ZL50016 is a maximum 1024 x 1024 channel non-blocking digital Time Division Multiplex (TDM) switch. It has sixteen input streams (STi0 - 15) and sixteen output streams (STio0 - 15). The device can switch 64 kbps and Nx64 kbps TDM channels from any input stream to any output stream. Each of the input and output streams can be independently programmed to operate at any of the following data rates: 2.048 Mbps, 4.096 Mbps, 8.192 Mbps or 16.384 Mbps. The ZL50016 provides up to eight high impedance control outputs (STOHZ0 - 7) to support the use of external tristate drivers for the first eight output streams (STio0 - 15). The output streams can be configured to operate in bi-directional mode, in which case STi0 - 15 will be ignored.

The device contains two types of internal memory - data memory and connection memory. There are four modes of operation - Connection Mode, Message Mode, BER mode and high impedance mode. In Connection Mode, the contents of the connection memory define, for each output stream and channel, the source stream and channel (the actual data to be output is stored in the data memory). In Message Mode, the connection memory is used for the storage of microprocessor data. Using Zarlink's Message Mode capability, microprocessor data can be broadcast to the data output streams on a per-channel basis. This feature is useful for transferring control and status information for external circuits or other TDM devices. In BER mode the output channel data is replaced with a pseudorandom bit sequence (PRBS) from one of 16 PRBS generators that generates a 2<sup>15</sup>-1 pattern. On the input side channels can be routed to one of 16 bit error detectors. In high impedance mode the selected output channel can be put into a high impedance state.

The configurable non-multiplexed microprocessor port allows users to program various device operating modes and switching configurations. Users can employ the microprocessor port to perform register read/write, connection memory read/write, and data memory read operations. The port is configurable to interface with either Motorola or Intel-type microprocessors.

The device also supports the mandatory requirements of the IEEE-1149.1 (JTAG) standard via the test port.

# **Table of Contents**

Features	
Applications	
Description	
Changes Summary	
1.0 Pinout Diagrams	
1.1 BGA Pinout	
2.0 Pin Description.	
3.0 Device Overview	
<b>4.0 Data Rates and Timing</b> 4.1 External High Impedance Control, STOHZ0 - 7	
4.1 External High Impedance Control, STOR20 - 7	
5.0 ST-BUS and GCI-Bus Timing	
•	
6.0 Output Timing Generation	
7.0 Data Input Delay and Data Output Advancement	
7.1 Input Bit Delay Programming.	
7.2 Input Bit Sampling Point Programming	
7.4 Fractional Output Bit Advancement Programming	
7.5 External High Impedance Control Advancement.	
8.0 Data Delay Through the Switching Paths	
8.1 Variable Delay Mode	
8.2 Constant Delay Mode	
9.0 Connection Memory Description	
10.0 Connection Memory Block Programming	
10.1 Memory Block Programming Procedure	
11.0 Device Operation in Divided Clock and Multiplied Clock Modes	
11.1 Divided Clock Mode Operation	
11.2 Multiplied Clock Mode Operation.	. 31
11.3 Output Clock Frequencies.	. 31
12.0 Microprocessor Port.	. 32
13.0 Device Reset and Initialization	. 32
13.1 Power-up Sequence	
13.2 Device Initialization on Reset	
13.3 Software Reset	
14.0 Pseudo Random Bit Generation and Error Detection	. 33
15.0 PCM A-law/m-law Translation	. 34
16.0 Quadrant Frame Programming	. 34
17.0 JTAG Port	
17.1 Test Access Port (TAP)	
17.2 Instruction Register	
17.3 Test Data Registers.	
17.4 BSDL	
18.0 Register Address Mapping	
19.0 Detailed Register Description	
20.0 Memory	
20.1 Memory Address Mappings.	
20.2 Connection Memory Low (CM_L) Bit Assignment.	
20.3 Connection Memory High (CM_H) Bit Assignment	. 50

# **Table of Contents**

21.0 DC Parameters	
22.0 AC Parameters	

# List of Figures

Figure 1 - ZL50016 Functional Block Diagram	. 1
Figure 2 - ZL50016 256-Ball 17 mm x 17 mm PBGA (as viewed through top of package)	. 8
Figure 3 - ZL50016 256-Lead 28 mm x 28 mm LQFP (top view)	. 9
Figure 4 - Input Timing when CKIN1 - 0 bits = "10" in the CR	
Figure 5 - Input Timing when CKIN1 - 0 bits = "01" in the CR	19
Figure 6 - Input Timing when CKIN1 - 0 = "00" in the CR	19
Figure 7 - Output Timing for CKo0 and FPo0	21
Figure 8 - Output Timing for CKo1 and FPo1	21
Figure 9 - Output Timing for CKo2 and FPo2	22
Figure 10 - Output Timing for CKo3 and FPo3 with CKoFPo3SEL1-0="11"	22
Figure 11 - Input Bit Delay Timing Diagram (ST-BUS)	
Figure 12 - Input Bit Sampling Point Programming	
Figure 13 - Input Bit Delay and Factional Sampling Point	25
Figure 14 - Output Bit Advancement Timing Diagram (ST-BUS)	26
Figure 15 - Output Fractional Bit Advancement Timing Diagram (ST-BUS)	
Figure 16 - Channel Switching External High Impedance Control Timing	27
Figure 17 - Data Throughput Delay for Variable Delay    Image: Comparison of Com	
Figure 18 - Data Throughput Delay for Constant Delay	
Figure 19 - Timing Parameter Measurement Voltage Levels	
Figure 20 - Motorola Non-Multiplexed Bus Timing - Read Access	
Figure 21 - Motorola Non-Multiplexed Bus Timing - Write Access.	
Figure 22 - Intel Non-Multiplexed Bus Timing - Read Access	
Figure 23 - Intel Non-Multiplexed Bus Timing - Write Access	
Figure 24 - JTAG Test Port Timing Diagram	
Figure 25 - Frame Pulse Input and Clock Input Timing Diagram (ST-BUS).	
Figure 26 - Frame Pulse Input and Clock Input Timing Diagram (GCI-Bus)	
Figure 27 - ST-BUS Input Timing Diagram when Operated at 2, 4 or 8 Mbps	
Figure 28 - ST-BUS Input Timing Diagram when Operated at 16 Mbps	
Figure 29 - GCI-Bus Input Timing Diagram when Operated at 2, 4 or 8 Mbps	
Figure 30 - GCI-Bus Input Timing Diagram when Operated at 16 Mbps	
Figure 31 - ST-BUS Output Timing Diagram when Operated at 2, 4, 8 or 16 Mbps	
Figure 32 - GCI-Bus Output Timing Diagram when Operated at 2, 4, 8 or 16 Mbps	
Figure 33 - Serial Output and External Control	
Figure 34 - Output Drive Enable (ODE)	
Figure 35 - Input and Output Frame Boundary Offset	
Figure 36 - FPo0 and CKo0 Timing Diagram.	
Figure 37 - FPo1/3 and CKo1/3 Timing Diagram.	
Figure 38 - FPo2 and CKo2 Timing Diagram.	
Figure 39 - FPo3 and CKo3 Timing Diagram.	
Figure 40 - Output Timing (ST-BUS Format)	78

# List of Tables

Table 1 - CKi and FPi Configurations for Divided Clock Modes	17
Table 2 - CKi and FPi Configurations for Multiplied Clock Mode	18
Table 3 - Output Timing Generation	20
Table 4 - Delay for Variable Delay Mode	28
Table 5 - Connection Memory Low After Block Programming	30
Table 6 - Connection Memory High After Block Programming.         Image: Connetable Bafter Block Programming.         Image: Connecti	
Table 7 - ZL50016 Operating Modes	31
Table 8 - Generated Output Frequencies.	31
Table 9 - Input and Output Voice and Data Coding	34
Table 10 - Definition of the Four Quadrant Frames	
Table 11 - Quadrant Frame Bit Replacement.	35
Table 12 - Address Map for Registers (A13 = 0)	37
Table 13 - Control Register (CR) Bits.	38
Table 14 - Internal Mode Selection Register (IMS) Bits	40
Table 15 - Software Reset Register (SRR) Bits	41
Table 16 - Output Clock and Frame Pulse Control Register (OCFCR) Bits	42
Table 17 - Output Clock and Frame Pulse Selection Register (OCFSR) Bits	
Table 18 - FPo_OFF[n] Register (FPo_OFF[n]) Bits	
Table 19 - Internal Flag Register (IFR) Bits - Read Only	
Table 20 - BER Error Flag Register 0 (BERFR0) Blts - Read Only	
Table 21 - BER Receiver Lock Register 0 (BERLR0) Bits - Read Only	
Table 22 - Stream Input Control Register 0 - 15 (SICR0 - 15) Bits.	
Table 23 - Stream Input Quadrant Frame Register 0 - 15 (SIQFR0 - 15) Bits	49
Table 24 - Stream Output Control Register 0 - 15 (SOCR0 - 15) Bits	51
Table 25 - BER Receiver Start Register [n] (BRSR[n]) Bits	
Table 26 - BER Receiver Length Register [n] (BRLR[n]) Bits	
Table 27 - BER Receiver Control Register [n] (BRCR[n]) Bits	53
Table 28 - BER Receiver Error Register [n] (BRER[n]) Bits - Read Only.	
Table 29 - Address Map for Memory Locations (A13 = 1)	
Table 30 - Connection Memory Low (CM_L) Bit Assignment when CMM = 0	
Table 31 - Connection Memory Low (CM_L) Bit Assignment when CMM = 1	
Table 32 - Connection Memory High (CM_H) Bit Assignment	57

# **Changes Summary**

The following table captures the changes from the October 2004 issue.

Page	Item	Change
13	Pin Description "CKi" on page 13	Clarified pin description for CKi.
31	11.3, "Output Clock Frequencies"	<ul> <li>Added new section to describe output clock frequencies.</li> </ul>

#### 1.0 Pinout Diagrams

# 1.1 BGA Pinout

1	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	
А	$V_{SS}$	NC	NC	NC	NC	NC	NC	NC	NC	NC	NC	NC	NC	NC	NC	$V_{SS}$	A
в	NC	STi10	STi5	STi4	CKo2	STi0	CKo0	NC	V <sub>DD</sub> _ corea	FPi	CKi	IC_Open	IC_Open	IC_GND	ODE	NC	в
с	NC	STi9	V <sub>SS</sub>	STi7	STi6	STi1	CKo1	NC	V <sub>SS</sub>	IC_Open	IC_Open	IC_Open	IC_GND	V <sub>SS</sub>	STio15	NC	С
D	NC	STi11	V <sub>DD_IO</sub>	STi3	STi2	NC	NC	NC	NC	V <sub>SS</sub>	FPo_ OFF1	IC_GND	STio13	V <sub>DD_IO</sub>	STio14	NC	D
E	NC	STi14	STi8	V <sub>DD_IO</sub>	V <sub>SS</sub>	V <sub>DD</sub> _ core	NC	NC	NC	NC	V <sub>DD</sub> _ core	V <sub>SS</sub>	V <sub>DD_IO</sub>	STio12	FPo2	NC	E
F	NC	STi15	STi12	STi13	V <sub>DD_IO</sub>	V <sub>DD</sub> _ core	V <sub>DD</sub> _ core	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>DD</sub> _ core	V <sub>DD</sub> _ core	V <sub>DD_IO</sub>	IC_Open	FPo3	FPo_ OFF2	NC	F
G	NC	RESET	IC_GND	IC_Open	TDo	V <sub>DD_IO</sub>	$V_{SS}$	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>DD_IO</sub>	A12	A13	FPo1	FPo0	NC	G
н	NC	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>DD</sub> _ corea	NC	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub>	A7	A9	A10	FPo_ OFF0	A11	NC	н
J	NC	V <sub>DD_IOA</sub>	V <sub>DD_IOA</sub>	V <sub>SS</sub>	V <sub>SS</sub>	CKo3	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub>	A3	A4	A5	A8	A6	NC	J
к	NC	V <sub>SS</sub>	TMS	V <sub>SS</sub>	V <sub>DD</sub> _ corea	V <sub>DD_IO</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>DD_IO</sub>	IC_Open	A0	A2	A1	NC	к
L	NC	V <sub>DD</sub> _ corea	TRST	тск	V <sub>DD_IO</sub>	V <sub>DD</sub> _ core	V <sub>DD</sub> _ core	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>DD</sub> _ core	V <sub>DD</sub> _ core	V <sub>DD_IO</sub>	STio10	STio11	STio9	NC	L
м	NC	NC	TDi	D0	V <sub>SS</sub>	V <sub>DD</sub> _ core	V <sub>DD</sub> _ core	D6	D10	V <sub>DD</sub> _ core	V <sub>DD</sub> _ core	V <sub>SS</sub>	_ <u>MOT</u> _INTEL	MODE_ 4M0	STio8	NC	м
N	NC	NC	V <sub>DD_IO</sub>	STio0	STOHZ3	D1	D5	D7	D11	D13	R/W _WR	DTA_ RDY	STio4	V <sub>DD_IO</sub>	STOHZ5	NC	N
Ρ	NC	NC	V <sub>SS</sub>	STio1	STio3	STOHZ1	D3	D8	D14	NC	STio5	STOHZ4	STOHZ6	V <sub>SS</sub>	STOHZ7	NC	Ρ
R	NC	NC	STOHZ0	STio2	STOHZ2	D2	D4	D9	D12	D15	CS	DS_RD	MODE_ 4M1	STio6	STio7	NC	R
т	$V_{\rm SS}$	NC	NC	NC	NC	NC	NC	NC	NC	NC	NC	NC	NC	NC	NC	V <sub>SS</sub>	т
	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	_

**Note:** A1 corner identified by metallized marking. **Note:** Pinout is shown as viewed through top of package.

Figure 2 - ZL50016 256-Ball 17 mm x 17 mm PBGA (as viewed through top of package)

#### 1.2 QFP Pinout

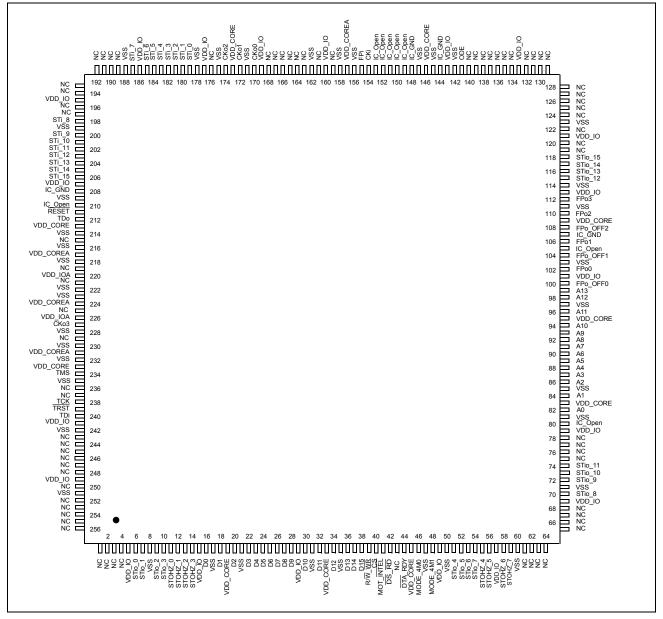


Figure 3 - ZL50016 256-Lead 28 mm x 28 mm LQFP (top view)

# 2.0 Pin Description

PBGA Pin Number	LQFP Pin Number	Pin Name	Description
E6, E11, F6, F7, F10, F11, L6, L7, L10, L11, M6, M7, M10, M11	19, 33, 45, 83, 95, 109, 146, 173, 213, 233	V <sub>DD_CORE</sub>	Power Supply for the core logic: +1.8 V
H4, K5, B9, L2	217, 231, 157, 224	V <sub>DD_COREA</sub>	Power Supply for analog circuitry: +1.8 V
D3, D14, E4, E13, F5, F12, G6, G11, K6, K11, L5, L12, N3, N14	5, 15, 29, 49, 57, 69, 79, 101, 113, 121, 133, 143, 160, 169, 177, 186, 195, 207, 241, 249	V <sub>DD_IO</sub>	Power Supply for I/O: +3.3 V
J2, J3	220, 226	V <sub>DD_IOA</sub>	Power Supply for the CKo5 and CKo3 outputs: +3.3 V
A1, A16, C3, C9, C14, D10, E5, E12, F8, F9, G7, G8, G9, G10, H2, H3, H6, H7, H8, H9, H10, J4, J5, J7, J8, J9, J10, K2, K4, K7, K8, K9, K10, L8, L9, M5, M12, P3, P14, T1, T16	8, 17, 21, 31, 35, 47, 50, 60, 71, 81, 85, 97, 103, 111, 114, 123, 142, 145, 147, 156, 158, 162, 171, 175, 178, 188, 199, 209, 214, 216, 218, 222, 223, 228, 230, 232, 235, 242, 251	V <sub>SS</sub>	Ground

PBGA Pin Number	LQFP Pin Number	Pin Name	Description
К3	234	TMS	<b>Test Mode Select (5 V-Tolerant Input with Internal Pull-up)</b> JTAG signal that controls the state transitions of the TAP controller. This pin is pulled high by an internal pull-up resistor when it is not driven.
L4	238	ТСК	Test Clock (5 V-Tolerant Schmitt-Triggered Input with Internal Pull-up)Provides the clock to the JTAG test logic.
L3	239	TRST	<b>Test Reset (5 V-Tolerant Input with Internal Pull-up)</b> Asynchronously initializes the JTAG TAP controller by putting it in the Test-Logic-Reset state. This pin should be pulsed low during power-up to ensure that the device is in the normal functional mode. When JTAG is not being used, this pin should be pulled low during normal operation.
M3	240	TDi	<b>Test Serial Data In (5 V-Tolerant Input with Internal Pull-up)</b> JTAG serial test instructions and data are shifted in on this pin. This pin is pulled high by an internal pull-up resistor when it is not driven.
G5	212	TDo	<b>Test Serial Data Out (5 V-Tolerant Three-state Output)</b> JTAG serial data is output on this pin on the falling edge of TCK. This pin is held in high impedance state when JTAG is not enabled.
B12, B13, C10, C11, F13, G4, K12, C12,	80, 105, 150, 151, 152, 153, 210, 149	IC_Open	Internal Test Mode (5 V-Tolerant Input with Internal Pull-down) These pins may be left unconnected.
G3, D12, B14, C13	144, 107, 148, 208	IC_GND	Internal Test Mode Enable (5 V-Tolerant Input) These pins MUST be low.

PBGA Pin Number	LQFP Pin Number	Pin Name	Description
A8, A9, A14,	61, 62,	NC	No Connect
A15, E10,	63, 64,		These pins MUST be left unconnected.
M2, N2, P2,	65, 66,		
P16, R2,	67, 68,		
R16, T6, T7,	134, 135,		
T8, T9, T10,	136, 137,		
T11, T12,	138, 139,		
T13, T14,	140, 215,		
T15, D16,	219, 225,		
E16, C16,	229, 236,		
B16, A13,	237, 125,		
A12, A10,	126, 127,		
A11, N1,	128, 129,		
M1, P1, R1,	130, 131,		
T2, T3, T5,	132, 253,		
T4, N16,	254, 255,		
M16, L16,	256, 1, 2,		
K16, H16,	3, 4, 75,		
J16, G16,	76, 77,		
F16,D9, E8,	78, 119,		
C8, E7, D6,	120, 122,		
H5, P10, E1,	124,159,		
D1, G1, F1,	163, 165,		
J1, H1, K1,	167, 176,		
L1, A7, A5,	221, 43,		
A6, A4, A3,	243, 244,		
A2, C1, B1,	245, 246,		
E9, D8, B8,	247, 248,		
D7	250, 252,		
	189, 190,		
	191, 192,		
	193, 194,		
	196, 197,		
	161, 164,		
	166, 168		
M14, R13	46, 48	MODE_4M0, MODE_4M1	<b>4M Input Clock Mode 0 to 1 (5 V-Tolerant Input with internal pull-down)</b> These two pins should be tied together and are typically used to select CKi = 4.096 MHz operation. See Table 7, "ZL50016 Operating Modes" on page 31 for a detailed explanation. See Table 13, "Control Register (CR) Bits" on page 38 for CKi and FPi selection using the CKIN1 - 0 bits.

PBGA Pin Number	LQFP Pin Number	Pin Name	Description
G15, G14, E15, F14	102, 106, 110, 112	FPo0 - 3	ST-BUS/GCI-Bus Frame Pulse Outputs 0 to 3 (5 V-Tolerant Three-state Outputs) FPo0: 8 kHz frame pulse corresponding to the 4.096 MHz output clock of CKo0. FPo1: 8 kHz frame pulse corresponding to the 8.192 MHz output clock of CKo1. FPo2: 8 kHz frame pulse corresponding to 16.384 MHz output clock of CKo2. FPo3: Programmable 8 kHz frame pulse corresponding to 4.096 MHz, 8.192 MHz, 16.384 MHz, or 32.768 MHz output clock of CKo3.
H14, D11, F15	100, 104, 108	FPo_OFF0 - 2	Generated Offset Frame Pulse Outputs 0 to 2 (5 V-Tolerant Three-state Outputs) Individually programmable 8 kHz frame pulses, offset from the output frame boundary by a programmable number of channels.
B7, C7, B5, J6	170, 172, 174, 227	CKo0 - 3	ST-BUS/GCI-Bus Clock Outputs 0 to 3 (5 V-Tolerant Three-state Outputs) CKo0: 4.096 MHz output clock. CKo1: 8.192 MHz output clock. CKo2: 16.384 MHz output clock. CKo3: 4.096 MHz, 8.192 MHz or 16.384 MHz programmable output clock. 32.768MHz if in multiplied clock mode.
B10	155	FPi	<b>ST-BUS/GCI-Bus Frame Pulse Input (5 V-Tolerant Schmitt-Triggered Input)</b> This pin accepts the frame pulse which stays active for 61 ns, 122 ns or 244 ns at the frame boundary. The frame pulse frequency is 8 kHz. The frame pulse associated with the CKi must be applied to this pin. If the data rate is 16.384 Mbps, a 61 ns wide frame pulse must be used. By default, the device accepts a negative frame pulse in ST-BUS format, but it can accept a positive frame pulse instead if the FPINP bit is set high in the Control Register (CR). It can accept a GCI-formatted frame pulse by programming the FPINPOS bit in the Control Register (CR) to high.
B11	154	СКі	ST-BUS/GCI-Bus Clock Input (5 V-Tolerant Schmitt-Triggered Input) This pin accepts a 4.096 MHz, 8.192 MHz or 16.384 MHz clock. In divided clock mode the clock frequency applied to this pin must be twice the highest input or output data rate. In multiplied clock mode the clock frequency applied to this pin must be twice the highest input data rate. The exception is, when data is running at 16.384 Mbps, a 16.384 MHz clock must be used. By default, the clock falling edge defines the input frame boundary, but the device allows the clock rising edge to define the frame boundary by programming the CKINP bit in the Control Register (CR).

PBGA Pin Number	LQFP Pin Number	Pin Name	Description
B6, C6, D5, D4, B4, B3, C5, C4, E3, C2, B2, D2, F3, F4, E2, F2	179, 180, 181, 182, 183, 184, 185, 187, 198, 200, 201, 202, 203, 204, 205, 206,	STi0 - 15	Serial Input Streams 0 to 15 (5 V-Tolerant Inputs with Internal Pull-downs) The data rate of each input stream can be selected independently using the Stream Input Control Registers (SICR[n]). In the 2.048 Mbps mode, these pins accept serial TDM data streams at 2.048 Mbps with 32 channels per frame. In the 4.096 Mbps mode, these pins accept serial TDM data streams at 4.096 Mbps with 64 channels per frame. In the 8.192 Mbps mode, these pins accept serial TDM data streams at 8.192 Mbps with 128 channels per frame. In the 16.384 Mbps mode, these pins accept TDM data streams at 16.384 Mbps with 256 channels per frame.
N4, P4, R4, P5, N13, P11, R14, R15, M15, L15, L13, L14, E14, D13, D15, C15	6, 7, 9, 10, 51, 52, 53, 54, 70, 72, 73, 74, 115, 116, 117, 118	STio 0 - 15	Serial Output Streams 0 to 15 (5 V-Tolerant Slew-Rate-Limited Three-state I/Os with Enabled Internal Pull-downs) The data rate of each output stream can be selected independently using the Stream Output Control Registers (SOCR[n]). In the 2.048 Mbps mode, these pins output serial TDM data streams at 2.048 Mbps with 32 channels per frame. In the 4.096 Mbps mode, these pins output serial TDM data streams at 4.096 Mbps with 64 channels per frame. In the 8.192 Mbps mode, these pins output serial TDM data streams at 8.192 Mbps with 128 channels per frame. In the 16.384 Mbps mode, these pins output serial TDM data streams at 16.384 Mbps with 256 channels per frame. These output streams can be used as bi-directionals by programming BDL (bit 6) of Internal Mode Selection (IMS) register.
R3, P6, R5, N5, P12, N15, P13, P15	11, 12, 13, 14, 55, 56, 58, 59	STOHZ 0 - 7	Serial Output Streams High Impedance Control 0 to 7 (5 V-Tolerant Slew-Rate-Limited Three-state Outputs) These pins are used to enable (or disable) external three-state buffers. When an output channel is in the high impedance state, the STOHZ drives high for the duration of the corresponding output channel. When the STio channel is active, the STOHZ drives low for the duration of the corresponding output channel. STOHZ outputs are available for STio0 - 7 only.
B15	141	ODE	<b>Output Drive Enable (5 V-Tolerant Input with Internal Pull-up)</b> This is the output enable control for STio0 - 15 and the output-driven-high control for STOHZ0 - 7. When it is high, STio0 - 15 and STOHZ0 - 7 are enabled. When it is low, STio0 - 15 are tristated and STOHZ0 - 7 are driven high.
M4, N6, R6, P7, R7, N7, M8, N8, P8, R8, M9, N9, R9, N10, P9, R10	16, 18, 20, 22, 23, 24, 25, 26, 27, 28, 30, 32, 34, 36, 37, 38	D0 - 15	Data Bus 0 to 15 (5 V-Tolerant Slew-Rate-Limited Three-state I/Os) These pins form the 16-bit data bus of the microprocessor port.

PBGA Pin Number	LQFP Pin Number	Pin Name	Description
N12	44	DTA_RDY	Data Transfer Acknowledgment_Ready (5 V-Tolerant Three-state Output) This active low output indicates that a data bus transfer is complete for the Motorola interface. For the Intel interface, it indicates a transfer is completed when this pin goes from low to high. An external pull-up resistor <b>MUST</b> hold this pin at HIGH level for the Motorola mode. An external pull-down resistor <b>MUST</b> hold this pin at LOW level for the Intel mode.
R11	40	CS	Chip Select (5 V-Tolerant Input) Active low input used by the Motorola or Intel microprocessor to enable the microprocessor port access.
N11	39	R/W_WR	<b>Read/Write_Write (5 V-Tolerant Input)</b> This input controls the direction of the data bus lines (D0 - 15) during a microprocessor access. For the Motorola interface, this pin is set high and low for the read and write access respectively. For the Intel interface, a write access is indicated when this pin goes low.
R12	42	DS_RD	Data Strobe_Read (5 V-Tolerant Input) This active low input works in conjunction with CS to enable the microprocessor port read and write operations for the Motorola interface. A read access is indicated when it goes low for the Intel interface.
K13, K15, K14, J11, J12, J13, J15, H11, J14, H12, H13, H15, G12, G13	82, 84, 86, 87, 88, 89, 90, 91, 92, 93, 94, 96, 98, 99	A0 - 13	Address 0 to 13 (5 V-Tolerant Inputs) These pins form the 14-bit address bus to the internal memories and registers.
M13	41	MOT_INTEL	<b>Motorola_Intel (5 V-Tolerant Input with Internal Pull-up)</b> This pin selects the Motorola or Intel microprocessor interface to be connected to the device. When this pin is unconnected or connected to high, Motorola interface is assumed. When this pin is connected to ground, Intel interface should be used.
G2	211	RESET	Device Reset (5 V-Tolerant Input with Internal Pull-up) This input (active LOW) puts the device in its reset state that disables the STio0 - 15 drivers and drives the STOHZ0 - 7 outputs to high. It also preloads registers with default values and clears all internal counters. To ensure proper reset action, the reset pin must be low for longer than 1 $\mu$ s. Upon releasing the reset signal to the device, the first microprocessor access cannot take place for at least 600 $\mu$ s due to the time required to stabilize the device from the power-down state. Refer to Section Section 13.2 on page 32 for details.

# 3.0 Device Overview

The device has sixteen ST-BUS/GCI-Bus inputs (STi0 - 15) and sixteen ST-BUS/GCI-Bus outputs (STio0 - 15). STio0 - 15 can also be configured as bi-directional pins, in which case STi0 - 15 will be ignored. It is a non-blocking digital switch with 1024 64 kbps channels and is capable of performing rate conversion between ST-BUS/GCI-Bus inputs and ST-BUS/GCI-Bus outputs. The ST-BUS/GCI-Bus inputs accept serial input data streams with data rates of 2.048 Mbps, 4.096 Mbps, 8.192 Mbps and 16.384 Mbps on a per-stream basis. The ST-BUS/GCI-Bus outputs deliver serial data streams with data rates of 2.048 Mbps, 8.192 Mbps and 16.384 Mbps, 4.096 Mbps, 8.192 Mbps and 16.384 Mbps on a per-stream basis. The device also provides eight high impedance control outputs (STOHZ0 - 7) to support the use of external ST-BUS/GCI-Bus tristate drivers for the first eight sixteen ST-BUS/GCI-Bus outputs (STiO -7).

By using Zarlink's message mode capability, microprocessor data stored in the connection memory can be broadcast to the output streams on a per-channel basis. This feature is useful for transferring control and status information for external circuits or other ST-BUS/GCI-Bus devices.

The device uses the ST-BUS/GCI-Bus input frame pulse (FPi) and the ST-BUS/GCI-Bus input clock (CKi) to define the input frame boundary and timing for sampling the ST-BUS/GCI-Bus input streams with various data rates. The output data streams will be driven by and have their timing defined by FPi and CKi in Divided Clock mode (CLKM bit 11 Table 13, Control Register (CR) Bits. In Multiplied Clock mode, the output data streams will be driven by an internally generated clock, which is multiplied from CKi internally. In Multiplied Clock mode, the output data streams will be driven by an internally generated clock, which is multiplied from CKi internally. Refer to Application Note ZLAN-120 for further explanation of the different modes of operation.

There are two clock modes for this device:

The first is the Divided Clock mode. In this mode, output streams are clocked by input CKi. Therefore the output streams have exactly the same jitter as the input streams. The output data rate can be the same as or lower than the input data rate, but the output data rate cannot be higher than what CKi can drive. For example, if CKi is 4.096 MHz, the output data rate cannot be higher than 2.048 Mbps. The second clock mode is called Multiplied Clock mode. In this mode, CKi is used to generate a 16.384 MHz clock internally, and output streams are driven by this internal clock. In Multiplied Clock mode, the data rate of output streams can be any rate, but output jitter may not be exactly the same as input jitter.

A Motorola or Intel compatible non-multiplexed microprocessor port allows users to program the device to operate in various modes under different switching configurations. Users can use the microprocessor port to perform internal register and memory read and write operations. The microprocessor port has a 16-bit data bus, a 14-bit address bus and six control signals (MOT\_INTEL, CS, DS\_RD, R/W\_WR and DTA\_RDY).

The device supports the mandatory requirements of the IEEE-1149.1 (JTAG) standard via the test port.

# 4.0 Data Rates and Timing

The ZL50016 has 16 serial data inputs and 16 serial data outputs. Each stream can be individually programmed to operate at 2.048 Mbps, 4.096 Mbps, 8.192 Mbps or 16.384 Mbps. Depending on the data rate there will be 32 channels, 64 channels, 128 channels or 256 channels, respectively, during a 125  $\mu$ s frame.

The output streams can be programmed to operate as bi-directional streams. By setting BDL (bit 6) in the Internal Mode Selection (IMS) register, the input streams 0 - 15 (STi0 - 15) are internally tied low, and the output streams 0 - 15 (STio0 - 15) are set to operate in a bi-directional mode. The input data rate is set on a per-stream basis by programming STIN[n]DR3 - 0 (bits 3 - 0) in the Stream Input Control Register 0 - 15 (SICR0 - 15). The output data rate is set on a per-stream basis by programming STO[n]DR3 - 0 (bits 3 - 0) in the Stream Output Control Register 0 - 15 (SICR0 - 15). The output data rates do not have to match or follow the input data rates. The maximum number of channels switched is limited to 1024 channels. If all 16 input streams were operating at 16.384 Mbps (256 channels per stream), this would result in 4096 channels. Memory limitations prevent the device from operating at this capacity. A maximum capacity of 1024 channels will occur if four of the streams are operating at 16.384 Mbps, eight of the streams are operating at 8.192 Mbps or all streams operating at 4.096 Mbps. With all streams operating at 2.048 Mbps, the capacity will be reduced to 512 channels. However, as each stream can be programmed to a different data rate, any combination of data rates can be achieved, as long as the total channel

count does not exceed 1024 channels. It should be noted that only full stream can be programmed for use. The device does not allow fractional streams.

#### 4.1 External High Impedance Control, STOHZ0 - 7

There are 16 external high impedance control signals, STOHZ0 - 7, that are used to control the external drivers for per-channel high impedance operations. Only the first eight ST-BUS/GCI-Bus (STio0 - 7) outputs are provided with corresponding STOHZ signals. The STOHZ outputs deliver the appropriate number of control timeslot channels based on the output stream data rate. Each control timeslot lasts for one channel time. When the ODE pin is high and the OSB (bit 2) of the Control Register (CR) is also high, STOHZ0 - 7 are enabled. When the ODE pin, OSB (bit 2) of the Control Register (CR) or the RESET pin is low, STOHZ0 - 7 are driven high, together with all the ST-BUS/GCI-Bus outputs being tristated. Under normal operation, the corresponding STOHZ outputs of any unused ST-BUS/GCI-Bus channel (high impedance) are driven high. Refer to Figure 16 on page 27 for a diagrammatical explanation.

#### 4.2 Input Clock (CKi) and Input Frame Pulse (FPi) Timing

The frequency of the input clock (CKi) for the ZL50016 depends on the operation mode selected. In divided clock mode, CKi must be at least twice the highest input or output data rate. For example, if the highest input data rate is 4.096 Mbps and the highest output data rate is 8.192 Mbps, the input clock, CKi, must be 16.384 MHz, which is twice the highest overall data rate. The only exception to this is for 16.384 Mbps input or output data. In this case, the input clock, CKi, is equal to the data rate. The input frame pulse, FPi, must always follow CKi. In multiplied clock mode the frequency of CKi must be at least twice the highest input data rate regardless of the output data rate. An APLL is used to multiple CKi to generate an internal clock that is used to output clocks and STio streams. Following the example above, if the highest input data rate is 4.096 Mbps, the input clock, CKi, must be 8.192 MHz, regardless of the output data rate. The only exception to this is for 16.384 Mbps input or output data. In this case, the input clock, CKi, is equal to the data rate. The input frame pulse, FPi, must always follow CKi.

In either mode the user has to program the CKIN1 - 0 (bits 6 - 5) in the Control Register (CR) to indicate the width of the input frame pulse and the frequency of the input clock supplied to the device.

Highest <u>Input or Output</u> Data Rate	CKIN 1-0 Bits	Input Clock Rate (CKi)	Input Frame Pulse (FPi)
16.384 Mbps or 8.192 Mbps	00	16.384 MHz	8 kHz (61 ns wide pulse)
4.096 Mbps	01	8.192 MHz	8 kHz (122 ns wide pulse)
2.048 Mbps	10	4.096 MHz	8 kHz (244 ns wide pulse)

 Table 1 - CKi and FPi Configurations for Divided Clock Modes

Highest <u>Input</u> Data Rate	CKIN 1-0 Bits	Input Clock Rate (CKi)	Input Frame Pulse (FPi)
16.384 Mbps or 8.192 Mbps	00	16.384 MHz	8 kHz (61 ns wide pulse)
4.096 Mbps	01	8.192 MHz	8 kHz (122 ns wide pulse)
2.048 Mbps	10	4.096 MHz	8 kHz (244 ns wide pulse)

#### Table 2 - CKi and FPi Configurations for Multiplied Clock Mode

The ZL50016 accepts positive and negative ST-BUS/GCI-Bus input clock and input frame pulse formats via the programming of CKINP (bit 8) and FPINP (bit 7) in the Control Register (CR). By default, the device accepts the negative input clock format and ST-BUS format frame pulses. However, the switch can also accept a positive-going clock format by programming CKINP (bit 8) in the Control Register (CR). A GCI-Bus format frame pulse can be used by programming FPINPOS (bit 9) and FPINP (bit 7) in the Control Register (CR).

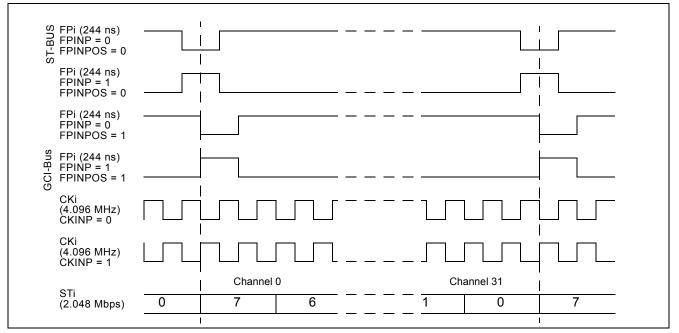


Figure 4 - Input Timing when CKIN1 - 0 bits = "10" in the CR

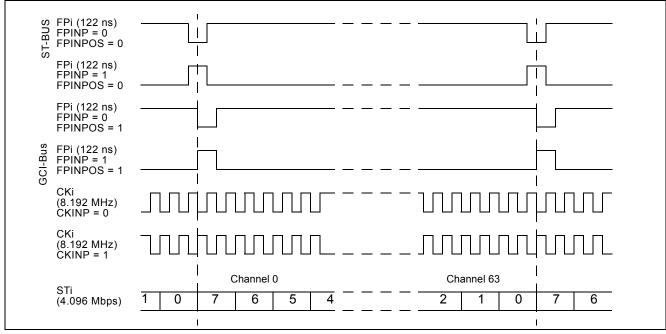


Figure 5 - Input Timing when CKIN1 - 0 bits = "01" in the CR

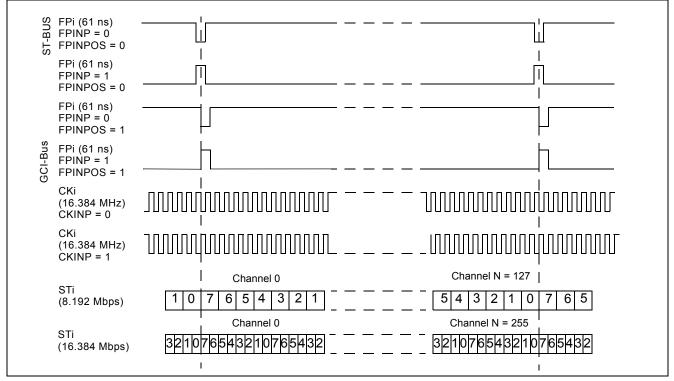


Figure 6 - Input Timing when CKIN1 - 0 = "00" in the CR

# 5.0 ST-BUS and GCI-Bus Timing

The ZL50016 is capable of operating using either the ST-BUS or GCI-Bus standards. The output timing that the device generates is defined by the bus standard. In the ST-BUS standard, the output frame boundary is defined by the falling edge of CKo while FPo is low. In the GCI-Bus standard, the frame boundary is defined by the rising edge of CKo while FPo goes high. The data rates define the number of channels that are available in a 125  $\mu$ s frame pulse period.

By default, the ZL50016 is configured for ST-BUS input and output timing. To set the input timing to conform to the GCI-Bus standard, FPINPOS (bit 9) and FPINP (bit 7) in the Control Register (CR) must be set. To set output timing to conform to the GCI-Bus standard, FPO[n]P and FPO[n]POS must be set in the Output Clock and Frame Pulse Selection Register (OCFSR). The CKO[n]P bits in the Output Clock and Frame Pulse Selection Register control the polarity (positive-going or negative-going) of the output clocks.

# 6.0 Output Timing Generation

The ZL50016 generates frame pulse and clock timing. There are four output frame pulse pins (FPo0 - 3) and four output clock pins (CKo0 - 3). All output frame pulses are 8 kHz output signals. By default, the output frame boundary is defined by the falling edge of the CKo0, while FPo0 is low. At the output frame boundary, the CKo1, CKo2 and CKo3 output clocks will by default have a falling edge, while FPo1, FPo2 and FPo3 will be low. The duration of the frame pulse low cycle and the frequency of the corresponding output clock are shown in Table 3 on page 20. Every frame pulse and clock output can be tristated by programming the enable bits in the Internal Mode Selection (IMS) register.

Pin Name	Output Timing Rate	Output Timing Unit
FPo0 pulse width	244	ns
CKo0	4.096	MHz
FPo1 pulse width	122	ns
CKo1	8.192	MHz
FPo2 pulse width	61	ns
CKo2	16.384	MHz
FPo3 pulse width	244, 122, 61 or 30	ns
CKo3	4.096, 8.192, 16.384 or 32.768	MHz

#### Table 3 - Output Timing Generation

The output timing is dependent on the operation mode that is selected. When the device is in Divided Clock mode, the frequencies on CKo0 - 3 cannot be greater than the input clock, CKi. For example, if the input clock is 8.192 MHz, the CKo2 pin will not produce a valid output clock and the CKo3 pin can only be programmed to output a 4.096 MHz or 8.192 MHz clock signal.

The device also delivers positive or negative output frame pulse and ST-BUS/GCI-Bus output clock formats via the programming of various bits in the Output Clock and Frame Pulse Selection Register (OCFSR). By default, the device delivers the negative output clock format. The ZL50016 can also deliver GCI-Bus format output frame pulses by programming bits of the Output Clock and Frame Pulse Selection Register (OCFSR). As there is a separate bit setting for each frame pulse output, some of the outputs can be set to operate in ST-BUS mode and others in GCI-Bus mode.

The following figures describe the usage of the FPO0P, FPO1P, FPO2P, FPO3P, CKO0P, CKO1P, CKO2P and CKO3P bits to generate the FPo0 - 3 and CKo0 - 3 timing.

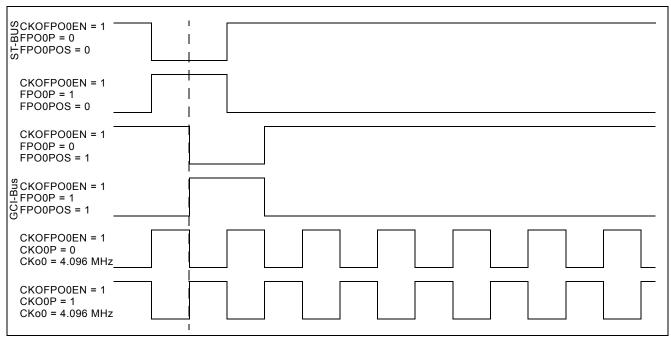


Figure 7 - Output Timing for CKo0 and FPo0

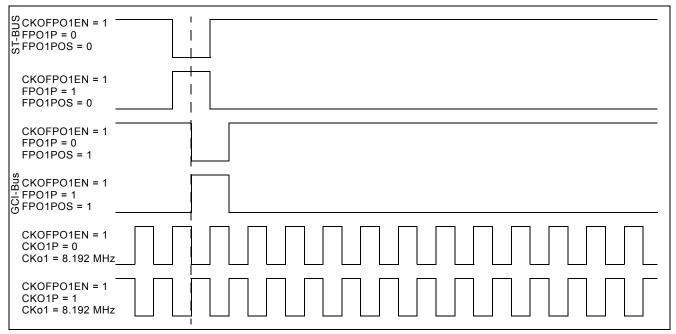


Figure 8 - Output Timing for CKo1 and FPo1

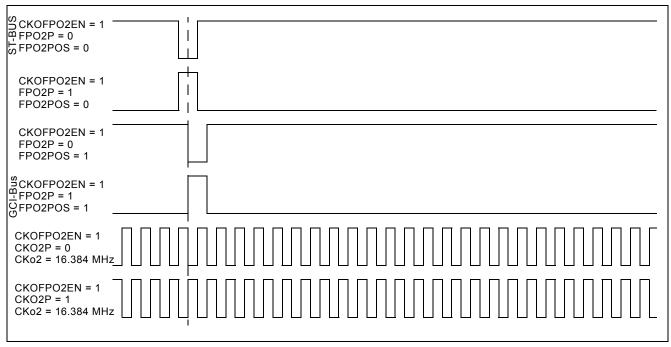


Figure 9 - Output Timing for CKo2 and FPo2

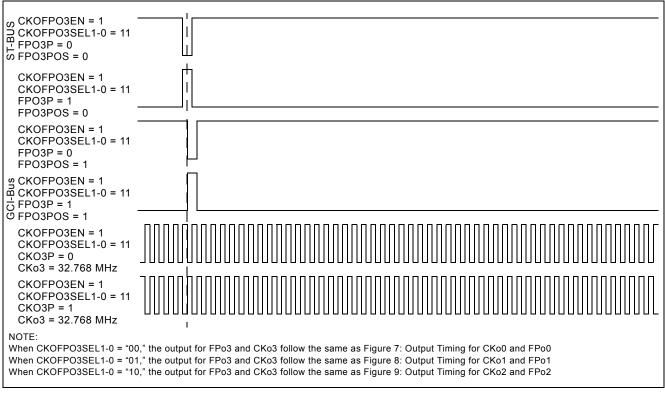


Figure 10 - Output Timing for CKo3 and FPo3 with CKoFPo3SEL1-0="11"

# 7.0 Data Input Delay and Data Output Advancement

Various registers are provided to adjust the input delay and output advancement for each input and output data stream. The input bit delay and output bit advancement can vary from 0 to 7 bits for each individual stream.

If input delay of less than a bit is desired, different sampling points can be used to handle the adjustments. The sampling point can vary from 1/4 to 4/4 with a 1/4-bit increment for all input streams, unless the stream is operating at 16.384 Mbps, in which case the fractional bit delay has a 1/2-bit increment. By default, the sampling point is set to the 3/4-bit location for non-16.384 Mbps data rates and the 1/2-bit location for the 16.384 Mbps data rate.

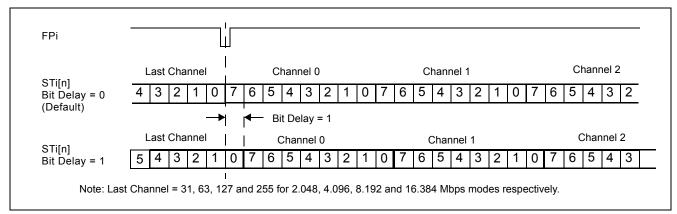
The fractional output bit advancement can vary from 0 to 3/4 bits, again with a 1/4-bit increment, unless the output stream is operating at 16.384 Mbps, in which case the output bit advancement has a 1/2-bit increment from 0 to 1/2 bit. By default, there is 0 output bit advancement.

Although input delay or output advancement features are available on streams which are operating in bi-directional mode it is not recommended, as it can easily cause bus contention. If users require this function special attention must be given to the timing to ensure contention is minimized.

#### 7.1 Input Bit Delay Programming

The input bit delay programming feature provides users with the flexibility of handling different wire delays when designing with source streams for different devices.

By default, all input streams have zero bit delay, such that bit 7 is the first bit that appears after the input frame boundary (assuming ST-BUS formatting). The input delay is enabled by STIN[n]BD2-0 (bits 8 - 6) in the Stream Input Control Register 0 - 15 (SICR0 - 15) as described in Table 22 on page 48. The input bit delay can range from 0 to 7 bits.



#### Figure 11 - Input Bit Delay Timing Diagram (ST-BUS)

#### 7.2 Input Bit Sampling Point Programming

In addition to the input bit delay feature, theZL50016 allows users to change the sampling point of the input bit by programming STIN[n]SMP 1-0 (bits 5 - 4) in the Stream Input Control Register 0 - 15 (SICR0 - 15). For input streams operating at any rate except 16.384 Mbps, the default sampling point is at 3/4 bit and users can change the sampling point to 1/4, 1/2, 3/4 or 4/4 bit position. When the stream is operating at 16.384 Mbps, the default sampling point is 1/2 bit and can be adjusted to a 4/4 bit position.

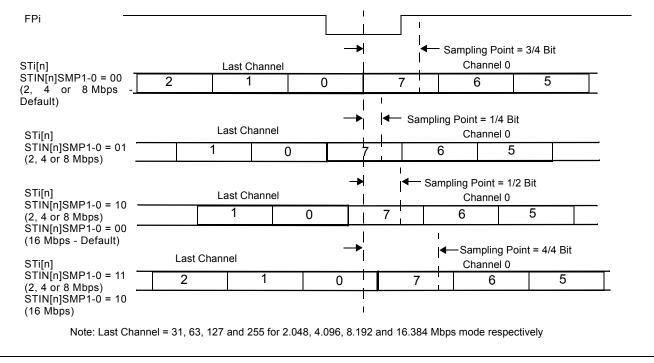
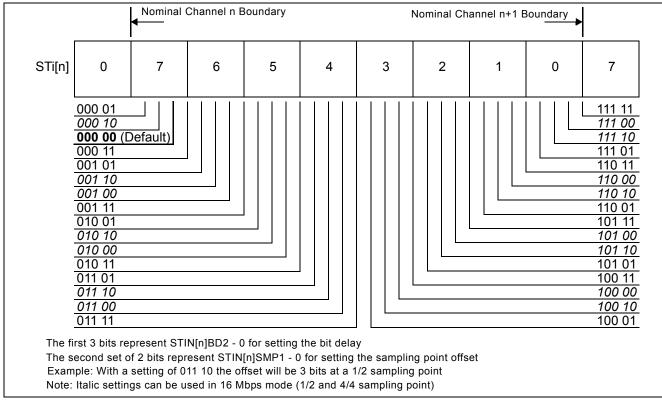


Figure 12 - Input Bit Sampling Point Programming

The input delay is controlled by STIN[n]BD2-0 (bits 8 - 6) to control the bit shift and STIN[n]SMP1 - 0 (bits 5 - 4) to control the sampling point in the Stream Input Control Register 0 - 15 (SICR0 - 15).



#### Figure 13 - Input Bit Delay and Factional Sampling Point

#### 7.3 Output Advancement Programming

This feature is used to advance the output data of individual output streams with respect to the output frame boundary. Each output stream has its own bit advancement value which can be programmed in the Stream Output Control Register 0 - 15 (SOCR0 - 15).

By default, all output streams have zero bit advancement such that bit 7 is the first bit that appears after the output frame boundary (assuming ST-BUS formatting). The output advancement is enabled by STO[n]AD 2 - 0 (bits 6 - 4) of the Stream Output Control Register 0 - 15 (SOCR0 - 15) as described in Table 24 on page 51. The output bit advancement can vary from 0 to 7 bits.

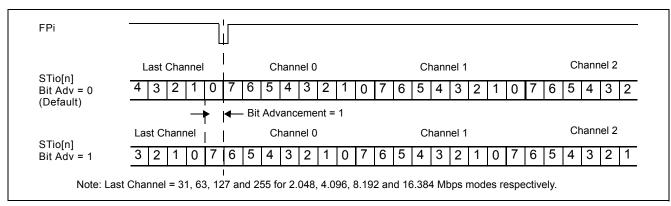


Figure 14 - Output Bit Advancement Timing Diagram (ST-BUS)

### 7.4 Fractional Output Bit Advancement Programming

In addition to the output bit advancement, the device has a fractional output bit advancement feature that offers better resolution. The fractional output bit advancement is useful in compensating for varying parasitic load on the serial data output pins.

By default all of the streams have zero fractional bit advancement such that bit 7 is the first bit that appears after the output frame boundary. The fractional output bit advancement is enabled by STO[n]FA 1 - 0 (bits 8 - 7) in the Stream Output Control Register 0 - 15 (SOCR0 - 15). For all streams running at any data rate except 16.384 Mbps the fractional bit advancement can vary from 0, 1/4, 1/2 to 3/4 bits. For streams operating at 16.384 Mbps, the fractional bit advancement can be set to either 0 or 1/2 bit.

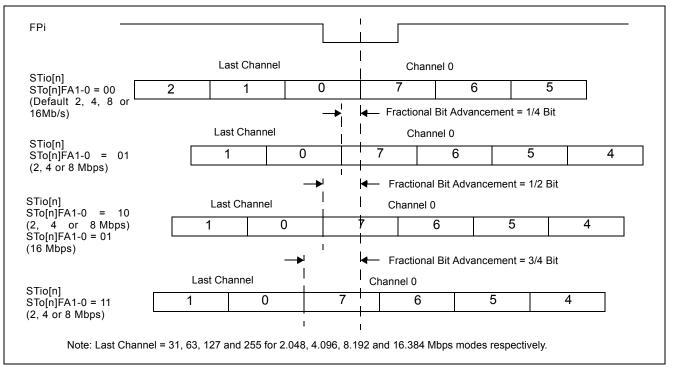


Figure 15 - Output Fractional Bit Advancement Timing Diagram (ST-BUS)

#### 7.5 External High Impedance Control Advancement

The external high impedance signals can be programmed to better match the timing required by the external buffers. By default, the output timing of the STOHZ signals follows the programmed channel delay and bit offset of their corresponding ST-BUS/GCI-Bus output streams. In addition, for all high impedance streams operating at any data rate except 16.384 Mbps, the user can advance the STOHZ signals a further 0, 1/4, 1/2, 3/4 or 4/4 bits by programming STOHZ[n]A 2 - 0 (bit 11 - 9) in the Stream Output Control Register. When the stream is operating at 16.384 Mbps, the additional STOHZ advancement can be set to 0, 1/2 or 4/4 bits by programming the same register.

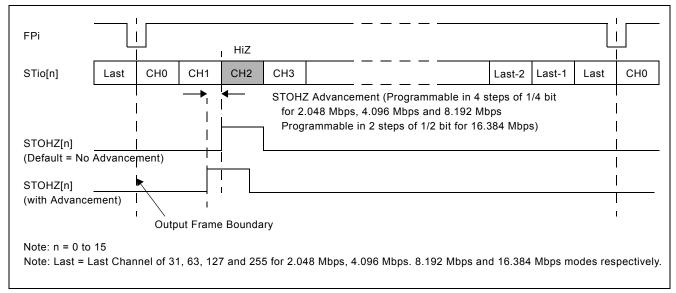


Figure 16 - Channel Switching External High Impedance Control Timing

# 8.0 Data Delay Through the Switching Paths

The switching of information from the input serial streams to the output serial streams results in a throughput delay. The device can be programmed to perform timeslot interchange functions with different throughput delay capabilities on a per-channel basis. For voice applications, select variable throughput delay to ensure minimum delay between input and output data. In wideband data applications, select constant delay to maintain the frame integrity of the information through the switch. The delay through the device varies according to the type of throughput delay selected by the V/ $\overline{C}$  (bit 14) in the Connection Memory Low when CMM = 0.

### 8.1 Variable Delay Mode

Variable delay mode causes the output channel to be transmitted as soon as possible. This is a useful mode for voice applications where the minimum throughput delay is more important than frame integrity. The delay through the switch can vary from 7 channels to 1 frame + 7 channels. To set the device into variable delay mode, VAREN (bit 4) in the Control Register (CR) must be set before V/C (bit 14) in the Connection Memory Low when CMM = 0. If the VAREN bit is not set and the device is programmed for variable delay mode, the information read on the output stream will not be valid.

In variable delay mode, the delay depends on the combination of the source and destination channels of the input and output streams.

m = input channel number	n-m <= 0	0 < n-m < 7	r	n-m = 7	n-m > 7
n = output channel number			STio < STi	STio >= STi	
T = Delay between input and output	1 frame - (m-n)	1 frame	+ (n-m)	n-m	

#### Table 4 - Delay for Variable Delay Mode

For example, if Stream 4 Channel 2 is switched to Stream 5 Channel 9 with variable delay, the data will be output in the same 125  $\mu$ s frame. Contrarily, if Stream 6 Channel 1 is switched to Stream 9 Channel 3, the information will appear in the following frame.

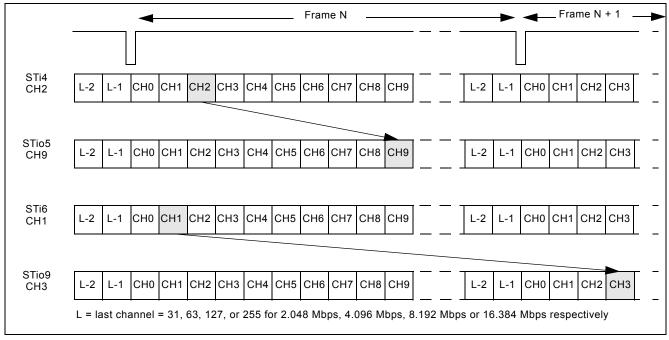


Figure 17 - Data Throughput Delay for Variable Delay

### 8.2 Constant Delay Mode

In this mode, frame integrity is maintained in all switching configurations. The delay though the switch is 2 frames -Input Channel + Output Channel. This can result in a minimum of 1 frame + 1 channel delay if the last channel on a stream is switched to the first channel of a stream. The maximum delay is 3 frames - 1 channel. This occurs when the first channel of a stream is switched to the last channel of a stream. The constant delay mode is available for all output channels.

The data throughput delay is expressed as a function of ST-BUS/GCI-Bus frames, input channel number (m) and output channel number (n). The data throughput delay (T) is:

#### T = 2 frames + (n - m)

The constant delay mode is controlled by  $V/\overline{C}$  (bit 14) in the Connection Memory Low when CMM = 0. When this bit is set low, the channel is in constant delay mode. If VAREN (bit 4) in the Control Register (CR) is set (to enable variable throughput delay on a chip-wide basis), the device can still be programmed to operate in constant delay mode.

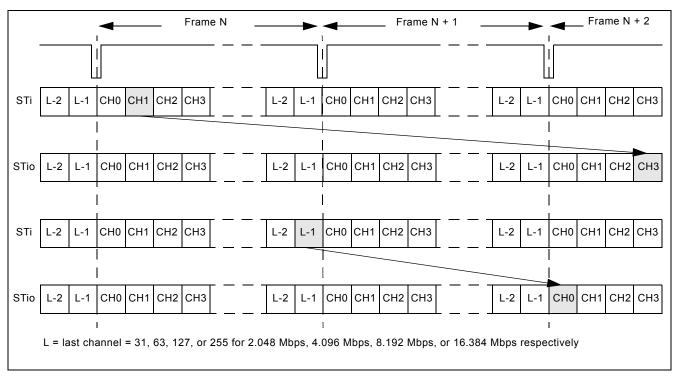


Figure 18 - Data Throughput Delay for Constant Delay

# 9.0 Connection Memory Description

The connection memory consists of two blocks, Connection Memory Low (CM\_L) and Connection Memory High (CM\_H). The CM\_L is 16 bits wide and is used for channel switching and other special modes. The CM\_H is 5 bits wide and is used for the voice coding function. When UAEN (bit 15) of the Connection Memory Low (CM\_L) is low,  $\mu$ -law/A-law conversion will be turned off and the contents of CM\_H will be ignored. Each connection memory location of the CM\_L or CM\_H can be read or written via the 16 bit microprocessor port within one microprocessor access cycle. See Table 29 on page 54 for the address mapping of the connection memory. Any unused bits will be reset to zero on the 16-bit data bus.

For the normal channel switching operation, CMM (bit 0) of the Connection Memory Low (CM\_L) is programmed low. SCA7 - 0 (bits 8 - 1) indicate the source (input) channel address and SSA4 - 0 (bits 13 - 9) indicate the source (input) stream address. The 5-bit contents of the CM\_H will be ignored during the normal channel switching mode without the  $\mu$ -law/A-law conversion when UAEN (bit 15) of the Connection Memory Low (CM\_L) is set to zero. If  $\mu$ -law/A-law conversion is required, the CM\_H bits must be programmed first to provide the voice/data information, the input coding law and the output coding law before the assertion of UAEN (bit 15) in the Connection Memory Low.

When CMM (bit 0) of the Connection Memory Low (CM\_L) is programmed high, the ZL50016 will operate in one of the special modes described in Table 31 on page 56. When the per-channel message mode is enabled, MSG7 - 0 (bit 10 - 3) in the Connection Memory Low (CM\_L) will be output via the serial data stream as message output data. When the per-channel message mode is enabled, the  $\mu$ -law/A-law conversion can also be enabled as required.

# 10.0 Connection Memory Block Programming

This feature allows for fast initialization of the connection memory after power up.

### 10.1 Memory Block Programming Procedure

- 1. Set MBPE (bit 3) in the Control Register (CR) from low to high.
- 2. Configure BPD2 0 (bits 3 1) in the Internal Mode Selection (IMS) register to the desired values to be loaded into CM\_L.
- Start the block programming by setting MBPS (bit 0) in the Internal Mode Selection Register (IMS) high. The values stored in BPD2 0 will be loaded into bits 2 0 of all CM\_L positions. The remaining CM\_L locations (bits 15 3) and the programmable values in the CM\_H (bits 4 0) will be loaded with zero values.

The following tables show the resulting values that are in the CM\_L and CM\_H connection memory locations.

Bit	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Value	0	0	0	0	0	0	0	0	0	0	0	0	0	BPD2	BPD1	BPD0

Table 5 - Connection Memory Low After Block Programming

Bit	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

#### Table 6 - Connection Memory High After Block Programming

Note: Bits 15 to 5 are reserved in Connection Memory High and should always be 0.

It takes at least two frame periods (250  $\mu$ s) to complete a block program cycle.

MBPS (bit 0) in the Control Register (CR) will automatically reset to a low position after the block programming process has completed.

MBPE (bit 3) in the Internal Mode Selection (IMS) register must be cleared from high to low to terminate the block programming process. This is not an automatic action taken by the device and must be performed manually.

**Note**: Once the block program has been initiated, it can be terminated at any time prior to completion by setting MBPS (bit 0) in the Control Register (CR) or MBPE (bit 3) in the Internal Mode Selection (IMS) register to low. If the MBPE bit was used to terminate the block programming, the MBPS bit will have to be set low before enabling other device operations.

# 11.0 Device Operation in Divided Clock and Multiplied Clock Modes

This device has two main operating modes - Divided Clock mode and Multiplied Clock mode.

In Multiplied Clock mode, output clocks and frame pulses are generated from an internal high-speed clock synchronized to CKi and FPi. Therefore, all specified output clock rates and data rates are available on CKo0-3 and STio0-31. In Divided Clock mode, output clocks and frame pulses are directly divided from CKi/FPi. Therefore, the output clock rate cannot exceed the CKi rate (the output data rates are also limited as per Table 1). The input data rate cannot exceed the CKi rate in either Multiplied or Divided Clock modes, because input data are always sampled directly by CKi.

Table 7, "ZL50016 Operating Modes" on page 31 summarizes the different modes of operation available within the ZL50016. Each Major mode (explained below) has various associated Minor modes that are determined by setting the MODE\_4M Input Control pins and the OPM bit in the Control Register (Table 13, "Control Register (CR) Bits" on page 38) indicated in the table.

Device		Input Pir	ıs	CR Register	Output Clock	Data Pins		
Operating	Mode	Control	Signal	Bit	Reference Lock	Enabled	С	lock Source
Major	Minor	MODE_4M [1:0]	СКі	OPM	CKo0-3	CKo0-3	STi	STo
Divided	4 M	11	4 M	0	CKi	Yes	CKi	CKo0-3
Clock	8/16 M	00	8/16 M					(CKi)
Multiplied	4 M	11	4 M	1	CKi MULT			CKo0-3
Clock 8/16 M	8/16 M	00	8/16 M					(CKi MULT)

X - Don't care or not applicable.

Reference Lock - Refers to what signal the output pins are locked to:

Cki = Bypass. Cki is passed directly through to CKo0-3.

Cki MULT = Cki is passed through clock multiplier to CKo0-3.

Clock Source - Refers to which clock samples STi and which clock outputs STo; STi applies when STi or STio is input; STo applies when STio is output.

Table 7 - ZL50016 Operating Modes

#### 11.1 Divided Clock Mode Operation

When the device is in Divided Clock mode, STio0 - 15 are driven by CKi. In this mode, the output streams and clocks have the same amount of jitter as the input clock (CKi), but the input and output data rate cannot exceed the input data rate defined by CKi. For example, if CKi is 4.096 MHz, the input and output data rate cannot be higher than 2.048 Mbps, and the generated output clock rates cannot exceed 4.096 MHz.

#### 11.2 Multiplied Clock Mode Operation

When the device is in Multiplied Clock mode, device hardware is used to multiply CKi internally. STio0 - are driven by this internally generated clock. In this mode, the output clocks and data can run at any of the specified rates, but they may have different jitter characteristics from the input clock (CKi). The input data rates are still limited by the CKi rate (as per Table 1), as input data are always sampled directly by CKi.

### 11.3 Output Clock Frequencies

The device can generate a limited number of clock and frame pulse output signals. All signals are synchronous to each other and are locked to the input CKi and FPi. The device can provide outputs with the following frequencies, with the exception that when in Divided Clock mode, the output clock rate cannot exceed the input CKi rate.

CKo0	4.096 MHz
CKo1	8.192 MHz
CKo2	16.384 MHz
CKo3	4.096 MHz, 8.192 MHz, 16.384 MHz or 32.768 MHz
FPo0	8 kHz (244 ns wide pulse)
FPo1	8 kHz (122 ns wide pulse)
FPo2	8 kHz (61 ns wide pulse)
FPo3	8 kHz (244 ns, 122 ns, 61 ns or 30 ns wide pulse)

#### Table 8 - Generated Output Frequencies

### 12.0 Microprocessor Port

The device provides access to the internal registers, connection memories and data memories via the microprocessor port. The microprocessor port is capable of supporting both Motorola and Intel non-multiplexed microprocessors. The microprocessor port consists of a <u>16-bit parallel data</u> bus (D15 - 0), 14 bit address bus (A13 - 0) and six control signals (MOT\_INTEL, CS, DS\_RD, R/W\_WR and DTA\_RDY).

The data memory can only be read from the microprocessor port. For a data memory read operation, D7 - 0 will be used and D15 - 8 will output zeros.

For a CM\_L read or write operation, all bits (D15 - 0) of the data bus will be used. For a CM\_H write operation, D4 - 0 of the data bus must be configured and D15 - 5 are ignored. D15 - 5 must be driven either high or low. For a CM\_H read operation, D4 - 0 will be used and D15 - 5 will output zeros.

Refer to Figure 20 on page 60, Figure 21 on page 61, Figure 22 on page 62 and Figure 23 on page 63 for the microprocessor timing.

### 13.0 Device Reset and Initialization

The RESET pin is used to reset the ZL50016. When this pin is low, the following functions are performed:

- · synchronously puts the microprocessor port in a reset state
- tristates the STio0 15 outputs
- · drives the STOHZ0 7 outputs to high
- preloads all internal registers with their default values (refer to the individual registers for default values)
- clears all internal counters

#### 13.1 Power-up Sequence

The recommended power-up sequence is for the V<sub>DD\_IO</sub> supply (normally +3.3 V) to be established before the power-up of the V<sub>DD\_CORE</sub> supply (normally +1.8 V). The V<sub>DD\_CORE</sub> supply may be powered up at the same time as V<sub>DD\_IO</sub>, but should not "lead" the V<sub>DD\_IO</sub> supply by more than 0.3 V.

### 13.2 Device Initialization on Reset

Upon power up, the ZL50016 should be initialized as follows:

- Set the ODE pin to low to disable the STio0 15 outputs and to drive STOHZ0 7 to high
- Set the TRST pin to low to disable the JTAG TAP controller
- Reset the device by pulsing the  $\overline{\text{RESET}}$  pin to zero for longer than 1  $\mu$ s
- After releasing the RESET pin from low to high, wait for a certain period of time (see Note below) for the device to stabilize from the power down state before the first microprocessor port access can occur
- Program CKIN1 0 (bit 6 -5) in the Control Register (CR) to define the frequency of the CKi and FPi inputs
- Wait at least 500 µs prior to the next microport access (see Note below)
- · Use the block programming mode to initialize the connection memory
- Release the ODE pin from low to high after the connection memory is programmed

**Note**: If CKi is 16.384 MHz, the waiting time is 500  $\mu$ s; if CKi is 8.192 MHz, the waiting time is 1 ms; if CKi is 4.096 MHz, the waiting time is 2 ms.

#### 13.3 Software Reset

In addition to the hardware reset from the  $\overline{RESET}$  pin, the device can also be reset by using software reset SRSTSW (bit 1) in the Software Reset Register (SRR).

# 14.0 Pseudo Random Bit Generation and Error Detection

The ZL50016 has one Bit Error Rate (BER) transmitter and one BER receiver for each pair of input and output streams, resulting in 16 transmitters connected to the output streams and 16 receivers associated with the input streams. Each transmitter can generate a BER sequence with a pattern of  $2^{15}$ -1 pseudorandom code (ITU O.151). Each transmitter can start at any location on the stream and will last for a minimum of 1 channel to a maximum of 1 frame time (125  $\mu$ s). The BER receivers and transmitters are enabled by programming the RBEREN (bit 5) and TBEREN (bit 4) in the IMS register. In order to save power, the 16 transmitters and/or receivers can be disabled. (This is the default state.)

Multiple connection memory locations can be programmed for BER tests such that the BER patterns can be transmitted for multiple consecutive output channels. If consecutive input channels are not selected, the BER receiver will not compare the bit patterns correctly. The number of output channels which the BER pattern occupies has to be the same as the number of channels defined in the BER Length Register (BRLR) which defines how many BER channels are to be monitored by the BER receiver.

For each input stream, there is a set of registers for the BER test. The registers are as follows:

- BER Receiver Control Register (**BRCR**) ST[n]CBER (bit 1) is used to clear the Bit Receiver Error Register (BRER). ST[n]SBER (bit 0) is used to enable the per-stream BER receiver.
- BER Receiver Start Register (**BRSR**) ST[n]BRS7 0 (bit 7 0) defines the input channel from which the BER sequence will start to be compared.
- BER Receiver Length Register (BRLR) ST[n]BL8 0 (bit 8 0) define how many channels the sequence will last. Depending on the data rate being used, the BER test can last for a maximum of 32, 64,or 128 channels at the data rates of 2.048, 4.096,or 8.192.Mbps, respectively. The minimum length of the BER test is a single channel. The user must take care to program the correct channel length for the BER test so that the channel length does not exceed the total number of channels available in the stream.
- BER Receiver Error Register (BRER) This read-only register contains the number of counted errors. When the error count reaches 0xFFFF, the BER counter will stop updating so that it will not overflow. ST[n]CBER (bit 1) in the BER Receiver Control Register is used to reset the BRER register.

For normal BER operation, CMM (bit 0) must be 1 in the Connection Memory Low (CM\_L) PCC1 - 0 (bits 2 - 1) in the Connection Memory Low must be programmed to "10" to enable the per-stream based BER transmitters. For each stream, the length (or total number of channels) of BER testing can be as long as one whole frame, but the channels MUST be consecutive. Upon completion of programming the connection memory, the corresponding BER receiver can be started by setting ST[n]SBER (bit 0) in the BRCR to high. There must be at least 2 frames (250  $\mu$ s) between completion of connection memory programming and starting the BER receiver before the BER receiver can correctly identify BER errors. A 16 bit BER counter is used to count the number of bit errors.

# **15.0 PCM A-law/**μ-law Translation

The ZL50016 provides per-channel code translation to be used to adapt pulse code modulation (PCM) voice or data traffic between networks which use different encoding laws. Code translation is valid in both Connection Mode and Message Mode.

In order to use this feature the Connection Memory High (CM\_H) entry for the output channel must be programmed. V/D (bit 4) defines if the traffic in the channel is voice or data. Setting ICL1 - 0 (bits 3 - 2) programs the input coding law and OCL1 - 0 (bits 1- 0) programs the output coding law as shown in Table 9.

Input Coding **Voice Coding Data Coding Output Coding**  $(\overline{V}/D \text{ bit} = 0)$  $(\overline{V}/D \text{ bit} = 1)$ (ICL1-0) (OCL1 - 0) ITU-T G.711 A-law 00 00 No code 01 01 ITU-T G.711 μ-law Alternate Bit Inversion (ABI) 10 10 A-law without Alternate Bit Inverted Alternate Bit Inversion (ABI) Inversion (ABI) 11 11 µ-law without Magnitude All bits inverted Inversion (MI)

The different code options are:

 Table 9 - Input and Output Voice and Data Coding

For voice coding options, the ITU-T G.711 A-law and ITU-T G.711  $\mu$ -law are the standard rules for encoding. A-law without Alternate Bit Inversion (ABI) is an alternative code that does not invert the even bits (6, 4, 2, 0).  $\mu$ -law without Magnitude Inversion (MI) is an alternative code that does not perform inversion of magnitude bits (6, 5, 4, 3, 2, 1, 0).

When transferring data code, the option "no code" does not invert the bits. The Alternate Bit Inversion (ABI) option inverts the even bits (6, 4, 2, 0) while the Inverted Alternate Bit Inversion (ABI) inverts the odd bits (7, 5, 3, 1). When the "All bits inverted" option is selected, all of the bits (7, 6, 5, 4, 3, 2, 1, 0) are inverted.

The input channel and output channel encoding law are configured independently. If the output channel coding is set to be different from the input channel, the ZL50016 performs translation between the two standards. If the input and output encoding laws are set to the same standard, no translation occurs. As the  $\overline{V}/D$  (bit 4) of the Connection Memory High (CM\_H) must be set on a per-channel basis, it is not possible to translate between voice and data encoding laws.

# 16.0 Quadrant Frame Programming

By programming the Stream Input Quadrant Frame Registers (SIQFR0 - 15), users can divide one frame of input data into four quadrant frames and can force the LSB or MSB of every input channel in these quadrants to one or zero for robbed-bit signaling. The four quadrant frames are defined as follows:

Data Rate	Quadrant 0	Quadrant 1	Quadrant 2	Quadrant 3
2.048 Mbps	Channel 0 - 7	Channel 8 - 15	Channel 16 - 23	Channel 24 - 31
4.096 Mbps	Channel 0 - 15	Channel 16 - 31	Channel 32 - 47	Channel 48 - 63
8.192 Mbps	Channel 0 - 31	Channel 32 - 63	Channel 64 - 95	Channel 96 - 127
16.384 Mbps	Channel 0 - 63	Channel 64 - 127	Channel 128 - 191	Channel 192 - 255

 Table 10 - Definition of the Four Quadrant Frames

When the quadrant frame control bits, STIN[n]Q3C2 - 0 (bit 11 - 9), STIN[n]Q2C2 - 0 (bit 8 - 6), STIN[n]Q1C2 - 0 (bit 5 - 3) or STIN[n]Q1C2 - 0 (bit 2 - 0), are set, the LSB or MSB of every input channel in the quadrant is forced to "1" or "0" as shown by the following table:

STIN[n]Q[y]C[2:0]	Action
0xx	Normal Operation
100	Replaces LSB of every channel in Quadrant y with '0'
101	Replaces LSB of every channel in Quadrant y with '1'
110	Replaces MSB of every channel in Quadrant y with '0'
111	Replaces MSB of every channel in Quadrant y with '1'
<b>Note:</b> y = 0, 1, 2, 3	•

#### Table 11 - Quadrant Frame Bit Replacement

Note that Quadrant Frame Programming and BER reception cannot be used simultaneously on the same input stream.

# 17.0 JTAG Port

The JTAG test port is implemented to meet the mandatory requirements of the IEEE-1149.1 (JTAG) standard. The operation of the boundary-scan circuitry is controlled by an external Test Access Port (TAP) Controller.

#### 17.1 Test Access Port (TAP)

The Test Access Port (TAP) accesses the ZL50016 test functions. It consists of three input pins and one output pin as follows:

- **Test Clock Input (TCK)** TCK provides the clock for the test logic. TCK does not interfere with any on-chip clock and thus remains independent in the functional mode. TCK permits shifting of test data into or out of the Boundary-Scan register cells concurrently with the operation of the device and without interfering with the on-chip logic.
- **Test Mode Selection Inputs (TMS)** The TAP Controller uses the logic signals received at the TMS input to control test operations. The TMS signals are sampled at the rising edge of the TCK pulse. This pin is internally pulled to high when it is not driven from an external source.
- **Test Data Input (TDi)** Serial input data applied to this port is fed either into the instruction register or into a test data register, depending on the sequence previously applied to the TMS input. The registers are described in a subsequent section. The received input data is sampled at the rising edge of the TCK pulse. This pin is internally pulled to high when it is not driven from an external source.
- **Test Data Output (TDo)** Depending on the sequence previously applied to the TMS input, the contents of either the instruction register or test data register are serially shifted out towards TDo. The data from TDo is clocked on the falling edge of the TCK pulses. When no data is shifted through the boundary scan cells, the TDo driver is set to a high impedance state.
- **Test Reset (TRST)** Resets the JTAG scan structure. This pin is internally pulled to high when it is not driven from an external source.

### 17.2 Instruction Register

The ZL50016 uses the public instructions defined in the IEEE-1149.1 standard. The JTAG interface contains a four-bit instruction register. Instructions are serially loaded into the instruction register from the TDi when the TAP Controller is in its shifted-OR state. These instructions are subsequently decoded to achieve two basic functions: to select the test data register that may operate while the instruction is current and to define the serial test data register path that is used to shift data between TDi and TDo during data register scanning.

#### 17.3 Test Data Registers

As specified in the IEEE-1149.1 standard, the ZL50016 JTAG interface contains three test data registers:

- **The Boundary-Scan Register** The Boundary-Scan register consists of a series of boundary-scan cells arranged to form a scan path around the boundary of the ZL50016 core logic.
- **The Bypass Register** The Bypass register is a single stage shift register that provides a one-bit path from TDi to TDo.
- The Device Identification Register The JTAG device ID for the ZL50016 is 0C36014BH

Version	<31:28>	0000
Part Number	<27:12>	1100 0011 0110 0000
Manufacturer ID	<11:1>	0001 0100 101
LSB	<0>	1

#### 17.4 BSDL

A Boundary Scan Description Language (BSDL) file is available from Zarlink Semiconductor to aid in the use of the IEEE-1149.1 test interface.

## 18.0 Register Address Mapping

Address	CPU	Register	Abbreviation	Reset By
A13 - A0	Access	Name		
0000 <sub>H</sub>	R/W	Control Register	CR	Switch/Hardware
0001 <sub>H</sub>	R/W	Internal Mode Selection Register	IMS	Switch/Hardware
0002 <sub>H</sub>	R/W	Software Reset Register	SRR	Hardware Only
0003 <sub>H</sub>	R/W	Output Clock and Frame Pulse Control Register	OCFCR	Hardware
0004 <sub>H</sub>	R/W	Output Clock and Frame Pulse Selection Register	OCFSR	Hardware
0005 <sub>H</sub>	R/W	FPo_OFF0 Register	FPOFF0	Hardware
0006 <sub>H</sub>	R/W	FPo_OFF1 Register	FPOFF1	Hardware
0007 <sub>H</sub>	R/W	FPo_OFF2 Register	FPOFF2	Hardware
0010 <sub>H</sub>	R Only	Internal Flag Register	IFR	Switch/Hardware
0011 <sub>H</sub>	R Only	BER Error Flag Register 0	BERFR0	Switch/Hardware
0013 <sub>H</sub>	R Only	BER Receiver Lock Register 0	BERLR0	Switch/Hardware
0100 <sub>H</sub> - 010F <sub>H</sub>	R/W	Stream Input Control Registers 0 - 15	SICR0 - 15	Switch/Hardware
0120 <sub>H</sub> - 012F <sub>H</sub>	R/W	Stream Input Quadrant Frame Registers 0 - 15	SIQFR0 - 15	Switch/Hardware
0200 <sub>H</sub> - 020F <sub>H</sub>	R/W	Stream Output Control Registers 0 - 15	SOCR0 - 15	Switch/Hardware
0300 <sub>H</sub> - 030F <sub>H</sub>	R/W	BER Receiver Start Registers 0 - 15	BRSR0 - 15	Switch/Hardware
0320 <sub>H</sub> - 032F <sub>H</sub>	R/W	BER Receiver Length Registers 0 - 15	BRLR0 - 15	Switch/Hardware
0340 <sub>H</sub> - 034F <sub>H</sub>	R/W	BER Receiver Control Registers 0 - 15	BRCR0 - 15	Switch/Hardware
0360 <sub>H</sub> - 036F <sub>H</sub>	R Only	BER Receiver Error Registers 0 - 15	BRER0 - 15	Switch/Hardware

Table 12 - Address Map for Registers (A13 = 0)

## 19.0 Detailed Register Description

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	
0	0	0	0	OPM	0	FPIN POS	CKINP	FPINP	CKIN 1	CKIN 0	VAR EN	MBPE	OSB	MS1	MS0	
Bit	Na	me						De	scripti	on						
15 - 12	Unu	ised	Reser	ved. In	norm	al func	tional m	ode, the	ese bit	s MUS	T be se	et to zer	ю.			
11	OF	PM	This b	ition M it is use ting Mo	ed to a	set the on page	device e 31 for	in Mast more d	er/Slavetails.	ve ope	ration.	Refer t	o Tabl	e 7, "Z	L500′	
10	Unu	ised	Reser	erating Modes" on page 31 for more details. served. In normal functional mode, this bits MUST be set to zero. but Frame Pulse (FPi) Position lien this bit is low, FPi straddles frame boundary (as defined by ST-BUS).												
9	FPIN	POS	When	this bit	is low	, FPi si	traddles	frame	bounda le bour	ary (as ndary (a	define as defi	d by ST ned by	-BUS) GCI-B	us)		
8	СК	INP	When	Input this bit this bit	is low	, the C	Ki fallin					e bound				
					0	,		iy euye	angno	with th	o nam	C Dound	iaiy.			
7	FPI	NP	Frame When	e Pulse this bi	Input t is lo	<b>t (FPi)</b> w, the	Polarity input fi	/ ame pu	ulse FF	Pi has	the ne	egative ve fram	frame			
7 6 - 5		NP I1 - 0	Frame When When	e Pulse this bi this bit	<b>Inpu</b> t is lo is hig	t <b>(FPi)</b> w, the h, the i	Polarity input fi nput fra	/ ame pu	ulse FF se FPi I	Pi has has the	the ne	egative	frame			
			Frame When When	e Pulse this bi this bit	Input t is lo is hig (CKi)	t <b>(FPi)</b> w, the h, the i	Polarity input fi nput fra	/ ame puls	ulse FF se FPi I <b>?i) Sele</b>	<sup>D</sup> i has has the ection	the ne	egative	frame			
			Frame When When	e Pulse this bi this bit	Input t is lo is hig (CKi)	t (FPi) w, the h, the i and Fr	Polarity input fi nput fra	/ rame pu me puls I <b>lse (FP</b> FPi Act	ulse FF se FPi I <b>?i) Sele</b>	<sup>D</sup> i has has the ection	the ne positi	egative ve fram	frame e pulse			
			Frame When When	e Pulse this bi this bit	Input t is lo is hig (CKi)	t (FPi) w, the h, the i and Fr IN1 - 0	Polarity input fi nput fra	/ rame puls Ilse (FP FPi Act	ulse FF se FPi I <b>?i) Sele</b> ive Peri	<sup>D</sup> i has has the ection	the ne positi	egative ve fram CKi	frame e pulso Hz			
			Frame When When	e Pulse this bi this bit	Input t is lo is hig (CKi)	t (FPi) w, the h, the i and Fr IN1 - 0 00	Polarity input fi nput fra	/ ame puls Ilse (FP FPi Act 6 12	ulse FF se FPi I Pi) Sele ive Peri 1 ns	<sup>D</sup> i has has the ection	the ne positi	egative ve fram CKi 6.384 MI	frame e pulso Hz Iz			
			Frame When When	e Pulse this bi this bit	Input t is lo is hig (CKi)	t <b>(FPi)</b> w, the h, the i <b>and Fr</b> IN1 - 0 00 01	Polarity input fi nput fra	/ ame puls Ilse (FP FPi Act 6 12	ulse FF se FPi I <b>?i) Sele</b> ive Peri 1 ns 2 ns	<sup>D</sup> i has has the ection	the ne e positi 11 8 4	egative ve fram CKi 6.384 MI 8.192 MF	frame e pulso Hz Iz			
			Frame When When Input	Pulse this bit this bit Clock	Input t is lo is hig (CKi) CK	t (FPi) w, the h, the i and Fr IN1 - 0 00 01 10 11 11 nd MO	Polarity input fra ame Pu be_4M	/ rame puls ilse (FP FPi Act 6 12 24	ulse FF se FPi I <b>ii) Sele</b> ive Peri 1 ns 2 ns 4 ns 4 ns	Pi has has the ection od Resen	the ne e positi 10 8 4 ved	egative ve fram CKi 6.384 MI 8.192 MF	frame e pulso Hz Iz Iz		at.	
	CKIN		Frame When When Input The M should Variat When	Pulse this bit this bit Clock Clock	Input t is lo is hig (CKi) CK CK	t (FPi) w, the h, the i and Fr IN1 - 0 00 01 10 11 nd MOI to defin de Ena	Polarity input fra rame Pu dame Pu DE_4M be the in able ariable of	rame puls me puls Ilse (FP FPi Act 6 12 24 1 pins, a put cloo	ulse FF se FPi I <b>i) Sele</b> ive Peri 1 ns 2 ns 4 ns as deso ck mod	Pi has has the ection od Resen cribed i e. disable	the ne e positi 10 8 ved n "Pin ed on a	egative ve fram CKi 6.384 Mi 8.192 MF	frame e pulse Hz Iz Iz otion" c	on page	e 10,	

## Table 13 - Control Register (CR) Bits

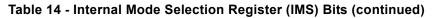
External Reset V		Write Add 000 <sub>H</sub>	ress: 0	000 <sub>H</sub>											
15	14	13	12	2 11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	OPM	0	FPIN POS	CKINP	FPINP	CKIN 1	CKIN 0	VAR EN	MBPE	OSB	MS1	MS0
Bit	N	ame						De	scripti	on					
2	C	DSB	This	put Stan bit enab cribes the	les the	STio					rial out	puts. Tł	ne follo	owing t	able
				RESET Pin	SRS (in S		ODE Pin	OSB Bit	S	Tio0 - 1	5		STOH	IZ0 - 7	
				0	>	<	Х	Х		HiZ				n High	
				1	1	1	Х	Х		HiZ				n High	
				1	0	)	0	Х		HiZ				n High	
				1	(	-	1	0		HiZ				n High	
				1	(	)	1	1	(Cont	Active rolled b	y CM)	(C	Act ontrolle	tive ed by C	M)
				e: Unuseo CR0 - 15			ams are	tristate	d (STio	) = HiZ	, STO⊦	IZ = Dri	ven H	igh). R	efer to
1 - 0	MS	S1 - 0	The	nory Sel se two bi for acces	ts are i	used t	o select	connec	tion me	emory	low, co	nnectio	n high	or dat	a mem-
					MS1 - (	0			Memo	ory Sele	ction				
					00			Connec	tion Me	mory Lo	ow Rea	d/Write			
					01			Connec	tion Me	mory Hi	gh Rea	d/Write			
					10				Data N	lemory	Read				
					11				R	eserveo	ł			]	
										-					

Table 13 - Control Register (CR) Bits (continued)

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	STIO_ PD_EN	0	BDL	RBER EN	TBER EN	BPD 2	BPD 1	BPD 0	MBPS
Bit		Name							Desci	ription					
15 - 9	L	Inused		Reserv	ed. In	norm	al functio	nal mo	de, thes	se bits N	IUST b	e set t	o zero		
8	ST	IO_PD EN	-		nis bit	is low	<b>able</b> , the pull- h, the pul								
7	L	Inused					al functio ctional mo		de, thes	se bits N	<b>IUST</b> b	e set t	o zero		
6		BDL		Bi-dire	ctiona	l Con	trol for S	Stream	s 0-15						
							<b>BDL</b> 0	bi ST	normal STi0-15 STio0-15 directio i0-15 tie	5 Operation operation of are input of are out of are out nal operation d low inter re bi-dire	on: uts puts ation: ernally				
5	RI	BEREN	1	<b>PRBS I</b> When this bit	nis bit	is low	, all the E	ER rec	ceivers	are disa	bled. T	o enat	ole any	/ BER	receiver
4	TI	BEREN	1	When t	his bi	t is lo	<b>Enable</b> ow, all th t <b>MUST</b> b			nitters	are dis	abled.	To e	nable	any BE
3 - 1	BI	PD2 - (	)	These I memory Registe the bits	oits ref / block r is se BPD2 Conne	er to c prog t to hi - 0 a	ng Data the value gramming igh and ti re loaded Memory	rfeatui ne MBI ⊺into bi	re is ac PS bit ir ts 2 - 0	tivated. this re of the 0	After t gister i Connec	he Mi s set t tion M	BPE b o high emory	it in th , the c Low. I	e Contr ontents Bits 15 -

## Table 14 - Internal Mode Selection Register (IMS) Bits

	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	STIO_ PD_EN	0	BDL	RBER EN	TBER EN	BPD 2	BPD 1	BPD 0	MBPS
Bit	r	Name							Descr	iption					
0	Ν	MBPS	A N C fi is is V f	A zero f MBPS a Dnce th rames shed, th s high, Wheney unctior	to one and BF ne MB to cor he MB MBPS ver the n is sta	trans PD2 - PE b nplete PS bit or M e micr rted.	ogrammine ition of the 0 bits in it in the the block t returns the BPE can oprocess As long a its in this	is bit s this reg Contro k prog to low, i be set or write is this b	tarts the jister mi Regist rammin ndicatir to low t to low t es a on- bit is hig	ust be c er is se g. After ng the o o abort e to the n, the u	defined et to hi the properation the pro MBPS user mu	in the gh, the ogram n is co gramr b bit, the st main	same e devi iming f implete ning of he bloo intain f	write ce rec functio ed. Wh peratic ck prog	operatio juires t n has f ien MB on. grammi me logi



	al Read/Writ Value: 0000		ss: 0002	Ч												
	15 14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	
	0 0	0	0	0	0	0	0	0	0	0	0	0	0	SRST SW	0	
Bit	No	me							Deer	rintia						
ЫІ	Na	me							Dest	criptio	n					
15 - 2	Unu	ised		<b>erved</b> ormal		onal m	ode, th	iese b	its <b>MU</b>	ST be	set to	zero.				
1	SRS	TSW	Whe swit	en this ching	blocks	low, s are i	witchin n soft	ng blo ware	reset :	state.	Refer	to Tal	ble 12	/hen thi , "Addre ers are a	ess Ma	ap for
0	Unı	ised		<b>erved</b> ormal		onal m	ode, th	iese b	its <b>MU</b>	ST be	set to	zero.				

## Table 15 - Software Reset Register (SRR) Bits

		0000 <sub>H</sub>				_	_	_	-	_		_			
15 0	14 0	13 0	12 0	11 0	10 0	9	8 FPOF2 EN	7 FPOF1 EN	6 FPOF0 EN	5 0	4	3 CKO FPO3	2 CKO FPO2	1 CKO FPO1	0 CKO FPO0
												EN	EN	EN	EN
Bit		Nam	е						Descr	iption					
15 - 9		Unus	ed	Rese In nor		Inctior	nal mode	, these b	its <b>MUS</b>	<b>T</b> be se	t to zer	D.			
8	I	FPOF2	2EN	In normal functional mode, these bits <b>MUST</b> be set to zero. <b>FPo_OFF2 Enable</b> When this bit is high, output frame pulse FPo_OFF2 When this bit is low, output frame pulse FPo_OFF2. <b>FPo_OFF1 Enable</b>											
7	1	FPOF1	EN	When	this b	it is hi	<b>le</b> igh, outp w, outpu	ut frame t frame p	pulse FF oulse FP	Po_OFF o_OFF	<sup>-</sup> 1 is en 1 is in h	abled. iigh imp	edance	e state.	
6	ł	FPOFC	)EN	When	OFF0 this b this b	it is hi	<b>le</b> igh, outp w, outpu	ut frame t frame p	pulse FF oulse FP	Po_OFF o_OFF	<sup>-</sup> 0 is en ) is in h	abled. igh imp	edance	e state.	
5		Unus	ed	Rese In nor		Inctior	nal mode	, these b	its <b>MUS</b>	T be se	t to zer	D.			
4		Unus	ed	<b>Rese</b> In nor		inctior	nal mode	, these b	its MUS	<b>T</b> be se	t to zer	0.			
3	(	CKOFF EN		When	this t	bit is h	<b>Enable</b> high, outp w, CKo3	out clock and FPo	CKo3 a o3 are in	and out high in	out fran	ne puls ce state	e FPo3 e.	3 are e	nable
2	(	CKOFF EN		When	this t	bit is h	<b>Enable</b> high, outp w, CKo2	out clock and FPo	CKo2 a 2 are in	and out high in	out fran	ne puls ce state	e FPoź	2 are e	nable
1	(	CKOFF EN		When	this t	bit is h	<b>Enable</b> high, outj w, CKo1	out clock and FPo	CKo1 a D1 are in	and out high in	out fran	ne puls ce state	e FPo´	l are e	nable
0	(	CKOFF EN			this t	bit is h	<b>Enable</b> high, out	out clock	CKo0 a	and out	out fran	ne puls	e FPo(	) are e	nable

Table 16 - Output Clock and Frame Pulse Control Register (OCFCR) Bits

15	14 13	12 11	10	9	8	7	6	5	4	3	2	1	0
0	FPO3 FI	KO CKO3 PO3 P EL0	FPO3 P	FPO3 POS	CKO2 P	FPO2 P	FPO2 POS	CKO1 P	FPO1 P	FPO1 POS	CKO0 P	FPO0 P	FPO0 POS
Bit	Name						Descri	ption					
15 - 14	Unused	Reserve In norma		onal mo	ode, the	ese bits	MUST	be set	to zero	).			
13 - 12	CKOFPO3 SEL1 - 0	Output Selectio		(CKo3)	Frequ	iency a	and Ou	utput F	rame	Pulse	(FPo3)	Pulse	Cycle
				CKOF SEL			FPo3		С	Ko3			
				0	0		244 ns			96 MHz			
				0			122 ns			92 MHz			
				1	-		61 ns			84 MHz			
				1	1		30 ns		32.1	68 MHz			
11	CKO3P												
		Output When the boundar frame bo	y. Whe	is low, n this l	the o	utput c	lock C						
10	FPO3P	When the boundar	his bit y. When bundary Frame I is bit is	is low, n this l <b>Pulse (</b> low, the	the o bit is h ( <b>FPo3</b> ) e outpu	igh, the <b>Polarit</b>	elock C e outpu y Seleo pulse f	t clock ction Po3 h	CKo3	rising	edge a	ligns w	format.
10 9		When the boundary frame boundary fra	his bit y. When bundary Frame I is bit is is bit is Frame I is bit is	is low, n this l Pulse ( low, the high, th Pulse ( low, FF	the o bit is h (FPo3) e outpu he outpu (FPo3) Po3 stra	Polarit Trame Trame Trame Positic	y Select pulse f pulse f pulse pulse	t clock ction FPo3 h FPo3 h	CKo3 as the r nas the	rising negative positive efined	edge a e frame e frame by ST-E	ligns w pulse f pulse f BUS).	format.
	FPO3P	When the boundary frame boundary frame boundary frame boundary when the when the <b>Output</b> When the <b>Output</b> When the boundary when the bou	nis bit y. When bundary Frame I is bit is is bit is is bit is is bit is Clock ( nis bit y. When	is low, n this l Pulse ( low, the high, th Pulse ( low, FF high, F CKo2) is low, n this l	the o bit is h (FPo3) e outpu he outpu Po3 stra Po3 stra Po3 stra the o	Polarit Polarit t frame ut frame addles f arts fror y Selecutput of	y Select pulse f pulse f pulse f m frame b m frame ction	t clock ction FPo3 h FPo3 h FPo3 h boundar boundar boundar boundar	CKo3 as the r has the ry (as d dary (as alling e	rising negative positive efined s define dge al	edge a e frame e frame by ST-E ed by G	Pulse f pulse f pulse f BUS). CI-Bus; ith the	ith the format format ).
9	FPO3P FPO3POS	When the boundary frame boundary frame boundary frame boundary when the When the When the When the When the When the boundary when the boundary boundary boundary frame boundary frame boundary when the boundary boundary frame bounda	his bit y. When bundary Frame I is bit is is bit is is bit is Frame I onis bit y. When bundary Frame I is bit is	is low, n this I Pulse ( low, the high, th Pulse ( low, FF high, F CKo2) is low, n this I Pulse ( low, the	the o pit is h (FPo3) e outpu e outpu Po3 stra Po3 stra Po3 stra Po3 stra (Po3 stra Po3 stra (Po3 stra (Po	Polarit Positic addles f arts from y Sele utput c igh, the Polarit t frame	y Select pulse F pulse F pulse F m frame b m frame ction ction clock C e outpu y Select pulse F	t clock ction FPo3 h FPo3 h FPo3 h boundar boundar boundar boundar boundar boundar boundar boundar ction FPo2 h	CKo3 as the r ry (as d dary (as alling e CKo2 as the r	rising negative positive efined s define dge all rising	edge a e frame e frame by ST-E ed by G igns w edge a e frame	iigns w pulse f pulse f BUS). CI-Bus; ith the ligns w	ith the format format ). frame ith the

## Table 17 - Output Clock and Frame Pulse Selection Register (OCFSR) Bits

15	14	13	12	2 11	10	9	8	7	6	5	4	3	2	1	0
0	0	CKO FPO3 SEL1	CK FPC SEL	03 P		FPO3 POS	CKO2 P	FPO2 P	FPO2 POS	CKO1 P	FPO1 P	FPO1 POS	CKO0 P	FPO0 P	FPO0 POS
						·									
Bit		Name							Descrij	ption					
5	CKO1P       Output Clock (CKo1) Polarity Selection         When this bit is low, the output clock CKo1 falling edge aligns with the frame boundary. When this bit is high, the output clock CKo1 rising edge aligns with the frame boundary.														
4		FPO1P		When	I <b>t Frame</b> this bit is this bit is	s low, th	e outpu	t frame	- pulse F	Po1 ha		0		•	
3	F	PO1PO	S	When	I <b>t Frame</b> this bit is this bit is	s low, Fl	Po1 stra	addles f	rame b						).
2		CKO0P		When bound	this bit ary. Wh boundar	is low, en this	the o	utput c	lock C						
1		FPO0P		When	I <b>t Frame</b> this bit is this bit is	s low, th	e outpu	t frame	pulse F	Po0 ha		0		•	
0	F	PO0PO	S	Outpu	it Frame	Pulse		Positic	n				by ST-E		

## Table 17 - Output Clock and Frame Pulse Selection Register (OCFSR) Bits (continued)

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0		OF[n] OFF7	FOF[n] OFF6	FOF[n] OFF5	FOF[n] OFF4	FOF[n] OFF3	FOF[n] OFF2	FOF[n] OFF1	FOF[n] OFF0	FOF[n] C1	FOF[n] C0
		New													
Bit		Nan	ne						De	escripti	on				
5 - 10	ι	Unus	sed	F	Reserved	. In noi	rmal fur	nctional	mode,	these bi	ts MUS	<b>F</b> be set	to zero	-	
9 - 2	FOF	[n]O	FF7 - (		Po_OFF										
					he binary Iry. Permi										ne boun
1 - 0	FO	)F[n](	C1 - 0	a		tted ch	annel o	offset va							ne boun
1 - 0	FO	)F[n](	C1 - 0	a	iry. Permi	tted ch	annel o	offset va i <b>ts</b> F		pend or	FOF[n]		register	rity	Position
1 - 0	FO	)F[n](	C1 - 0	a	ry. Permi Po_OFF	Ited ch	ntrol bi	offset va	llues de	pend or [n] Width	FOF[n] FOF[n] Per Chann	) of this OFF7 - 0 nitted	Pola	rity rol	Position Control
1 - 0	FO	)F[n](	C1 - 0	a	FOF[n]C	tted ch [n] Co Dat (N 2	ntrol bi ntrol bi ta Rate //bps)	offset va	Ilues de Po_OFF e Cycle \	pend or [n] Width z clock	FOF[n] FOF[n] Per Chann 0	) of this OFF7 - 0 mitted el Offset	Pola Cont	rity rrol 0P F	Position Control
1 - 0	FO	)F[n](	C1 - 0	a	ry. Permi FO_OFF FOF[n]C 1-0	Ited ch	ntrol bi ntrol bi ta Rate Abps)	offset va its F Puls one 4. one 8.	Po_OFF e Cycle \ 096 MH2	pend or [n] Width z clock z clock	FOF[n] FOF[n] Per Chann 0 0	OFF7 - 0 mitted el Offset - 31	Pola Cont FPO	rity rol 0P F 1P F	Position Control

Table 18 - FPo\_OFF[n] Register (FPo\_OFF[n]) Bits

	Read Address: 001 ue: 0000 <sub>H</sub>	0 <sub>H</sub>
	15 14 1	3 12 11 10 9 8 7 6 5 4 3 2 1 0
	0 0	0       0
Bit	Name	Description
15 - 2	Unused	Reserved In normal functional mode, these bits are zero.
1	OUTERR	Output Error (Read Only) This bit is set high when the total number of output channels is programmed to be more than the maximum capacity of 1024, in which case the output channels beyond the maximum capacity should be disabled. This bit will be cleared automatically after programming is corrected.
0	INERR	<b>Input Error (Read Only)</b> This bit is set high when the total number of input channels is programmed to be more than the maximum capacity of 1024, in which case the input channels beyond the maximum capacity should be disabled. This bit will be cleared automatically after programming is corrected.

Table 19 - Internal Flag Register (IFR) Bits - Read Only

Reset V	alue: 0000	ress: 00	011 <sub>H</sub>												
15		13	12	11	10	9	8	7	6	5	4	3	2	1	0
BEI F15		BER F13	BER F12	BER F11	BER F10	BER F9	BER F8	BER F7	BER F6	BER F5	BER F4	BER F3	BER F2	BER F1	BER F0
Bit	Nam	ıe						0	Descri	ption					
15 - 0	BERF	-[n]	lf BEI zero.	RF[n] i	•	it indi		hat BE at BEF				•		-	-/

## Table 20 - BER Error Flag Register 0 (BERFR0) Blts - Read Only

	15	ue: 0000 <sub>1</sub> 14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	BER L15	BER L14	BER L13	BER L12	BER L11	BER L10	BER L9	BER L8	BER L7	BER L6	BER L5	BER L4	BER L3	BER L2	BER L1	BER L0
Bit	t	Nam	ne							Descri	ption					

## Table 21 - BER Receiver Lock Register 0 (BERLR0) Bits - Read Only

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	STIN[n] BD2	STIN[n] BD1	STIN[n] BD0	STIN[n] SMP1	STIN[n] SMP0	STIN[n] DR3	STIN[n] DR2	STIN[n] DR1	STIN[n] DR0
Bi	t		N	lame	)					D	)escripti	on			
15 -	- 9		U	nuse	d		Reserve n normal		nal mode	, these b	oits MUS	T be set	to zero.		
8 -	6	Ś	STIN[	n]BC	)2 - 0	-	The binar	y value	Bit Delay of these lative to	, bits refe					
5 -	4	S	TIN[r	ז]SM	P1 -	0	nput Da	ta Samp	oling Poi	nt Selec	tion Bit	5			
							STIN[n]S	MP1-0	(2.048	8 Mbps, 4	npling Po .096 Mbp streams)		/lbps	(16.38	ing Point 34 Mbps eams)
							00	)		:	3/4 point			2/4	point
							01				1/4 point				
							10	)		:	2/4 point			4/4	point
							11				4/4 point				
3 -	0		STIN[	n]DF	R3 - C		nput Da	ta Rate S	Selectio	n Bits:					
									STIN[n][	DR3-0	I	Data Rate	;		
									000	0	Stre	eam Unus	sed		
								F	000	1	2	.048 Mbp	s	1	
								F	001	0	4	.096 Mbp	s	1	
								F	001	1	8	.192 Mbp	s	1	
									010	0	16	6.384 Mbp	os	1	
									0101 -	1111		Reserved		1	

## Table 22 - Stream Input Control Register 0 - 15 (SICR0 - 15) Bits

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	STIN[n] Q3C2	STIN[n] Q3C1	STIN[n] Q3C0	STIN[n] Q2C2	STIN[n] Q2C1	STIN[n] Q2C0	STIN[n] Q1C2	STIN[n] Q1C1	STIN[n] Q1C0	STIN[n] Q0C2	STIN[n] Q0C1	STIN[n] Q0C0
Bi	it		1	Name						Desci	ription				
5 -	12		U	nused		<b>Reserve</b> n norma		nal mod	le, thes	e bits <b>M</b>	IUST be	e set to	zero.		
11 -	- 9	S	IIN	n]Q3C2	T a	Quadran These thi Is Ch24 .096 Mb	ree bits to 31, C	are use Ch48 to	d to coi 63, Ch9	ntrol ST 96 to 12	7 and C	h192 to	255 for	r the 2.0	
							STIN[n 2-(	-			Ope	ration			
							0x:	x			normal	operatio	n		
							10	0	LS	SB of ead	ch chanr	nel is rep	laced by	"0"	
							10	1	LS	SB of ead	ch chanr	nel is rep	laced by	"1"	
							11(	0	M	SB of ea	ch chanr	nel is rep	laced by	ʻ "O"	
							11 <sup>.</sup>	1	M	SB of ea	ch chanr	nel is rep	laced by	· "1"	
8 -	6	S	TIN[	n]Q2C2	T a	Quadran These this S Ch16 5.096 Mb	ree bits to 23, 0	are use Ch32 to	d to coi 47, Chi	ntrol ST 64 to 95	and C	h128 to	191 for	the 2.0	
								V[n]Q2C 2-0			Ope	ration			
								0xx			normal	operatio	n		
								100	LS	SB of ead	ch chanr	nel is rep	laced by	"0"	
								101	LS	SB of ead	ch chanr	nel is rep	laced by	"1"	
								110	M	SB of ea	ch chani	nel is rep	laced by	<i>ı</i> "0"	

Table 23 - Stream Input Quadrant Frame Register 0 - 15 (SIQFR0 - 15) Bits

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	STIN[n] Q3C2	STIN[n] Q3C1	STIN[n] Q3C0	STIN[n] Q2C2	STIN[n] Q2C1	STIN[n] Q2C0	STIN[n] Q1C2	STIN[n] Q1C1	STIN[n] Q1C0	STIN[n] Q0C2	STIN[n] Q0C1	STIN[n] Q0C0
Bi	it			Name						Desc	ription				
5 -	3	S	TIN[	n]Q1C2	ti a	Quadran hese thro is Ch8 to .096 Mb	ee bits a o 15, C	are use h16 to	d to cor 31, Ch	ntrol STi 32 to 63	3 and C	h64 to	127 for	the 2.0	
							ST	IN[n]Q10 2-0			Ope	eration			
								0xx			normal	operatio	n		
								100	L	SB of ea	ich chan	nel is rep	laced by	′ "O"	
								101	L	SB of ea	ich chan	nel is rep	laced by	′ "1"	
								110	M	ISB of ea	ach chan	nel is re	placed by	/ "0"	
								111	Μ	ISB of ea	ach chan	nel is re	placed by	/ "1"	
2 -	0	S	TIN[	n]Q0C2	T a	Quadran These thi Is Ch0 1.096 Mb	ree bits to 7, C	are use Ch0 to	ed to co 15, Ch	ntrol ST 0 to 31	1 and 0	Ch0 to	63 for	the 2.0	
							STI	N[n]Q0C	2-0		Ор	eration			
								0xx			normal	operatio	n		
								100	L	SB of ea	ach chan	nel is re	placed by	/ "O"	
								101	L	SB of ea	ach chan	nel is re	placed by	/ "1"	
								110	N	ISB of ea	ach char	nel is re	placed b	y "0"	
								111	N	ISB of ea	ach char	nol ic ro		. "1"	

Table 23 - Stream Input Quadrant Frame Register 0 - 15 (SIQFR0 - 15) Bits (continued)

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	STOHZ [n]A2	STOHZ [n]A1	STOHZ [n]A0	STO[n] FA1	STO[n] FA0	STO[n] AD2	STO[n] AD1	STO[n] AD0	STO[n] DR3	STO[n] DR2	STO[n] DR1	STO[n] DR0
Bit			Na	me						Descri	iption				
15 - 1	2		Uni	used		eserved normal fu	unction	al mode	e, these	bits <b>M</b>	UST be	e set to	zero.		
11 - 9	9	ST	OHZ	[n]A2 - (	) <b>ST</b>	OHZ Ad	ditiona	ıl Adva	nceme	nt Bits					
		(Vali	d only	for STio0-7	·	STOHZ[n]	JA2-0		.048 Mb	al Advan ops, 4.09 92 Mbp	96 Mbps				ancemei streams
						000				0 bit				0 bit	
						001				1/4 bit				2/4 bi	-
						010				2/4 bit 3/4 bit				4/4 bi Reserv	-
						100				4/4 bit				TCSCI V	cu
						101-1	11			eserved					
8 - 7	8 - 7 STO[n]FA1 - 0				Οι	utput Str	eam[n]	Fracti	onal A	dvance	ement E	Bits)			
	8 - 7 STO[n]FA1 - 0					STO[n]FA	.1-0		.048 Mb	anceme ps, 4.09 lbps stre	6 Mbps,	,		Advance 34 Mbps	ment streams
						00				0				0	
						01				1/4 bit				2/4	
						10				2/4 bit				Reserv	ved
						11				3/4 bit					
6 - 4				AD2 - 0	Th is ad	u <b>tput Str</b> le binary to be ad vanceme	value o vanceo ent.	f these I relativ	bits ref e to FF	ers to tł Po. The	ne num	ber of b			•
3 - 0		ST	'O[n]	DR3 - 0	Οι	utput Dat	a Rate	Select	ion Bit	S					
							S	TIN[n]DI	R3 - 0		Da	ata Rate	1		
								0000	)			ed: STio Z driven			
								0001			2.0	48 Mbp	S		
								0010	)		4.0	96 Mbp	s		
								0011			8.1	92 Mbp	s		
								0100	)		16.3	384 Mbp	)S		
					1			0101 - 1	444			eserved			

Table 24 - Stream	<b>Output Control</b>	Register 0 - 15	(SOCR0 - 15) Bits
-------------------	-----------------------	-----------------	-------------------

Externa Reset \			ddres	s: 0300 <sub>H</sub>	- 030F	Н										
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	
0	0	0	0	0	0	0	0	ST[n] BRS7	ST[n] BRS6	ST[n] BRS5	ST[n] BRS4	ST[n] BRS3	ST[n] BRS2	ST[n] BRS1	ST[n] BRS0	
	-															
Bit		Name		Description												
15 - 8	L	Inused	1	Reser In norr		nction	al mo	de, thes	se bits N	<b>/UST</b> b	e set to	zero.				
7 - 0		ST[n] RS7 -	0		nary v	alue o		r <b>e Start</b> se bits r		the inp	out char	inel in w	hich th	e BER	data sta	irts
Note: [n] d	denote	s input	strea	m from 0	- 15.											



15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	ST[n] BL8	ST[n] BL7	ST[n] BL6	ST[n] BL5	ST[n] BL4	ST[n] BL3	ST[n] BL2	ST[n] BL1	ST[n] BL0
	1														
Bit		Name	•						De	scripti	on				
15 - 9		Name         Description           Unused         Reserved In normal functional mode, these bits MUST be set to zero.													
8 - 0		ST[n] BL8 -		The to to rec 256 f	oinary ceive t or the ctively	value he BE data i y. The	Length of these R patte rates of minimu be perfo	e bits re rn. The 2.048 N ım num	maximu Abps, 4.	um num 096 Mb	ber of E ps, 8.1	BER cha 92 Mbp	annels is s and 1	s 32, 64 6.384 N	,128 an Ibps

Table 26 - BER Receiver Length Register [n] (BRLR[n]) Bits

	l Read/Write alue: 0000 <sub>H</sub>		ess: 034	0 <sub>H</sub> - 034	4F <sub>H</sub>											
	15 14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	
	0 0	0	0	0	0	0	0	0	0	0	0	0	0	ST[n] CBER	ST[n] SBER	]
Bit	Nam	е		Description												
15 - 2	Unuse	ed		served normal functional mode, these bits MUST be set to zero.												
1	ST[n CBEI		Whe	n this	Bit E bit is Frror R	high	, it re	sets			bit er	ror co	ounte	r and th	ie strea	IM BER
0	ST[n SBEI	-	Whe error comp	n this test pletior	result	high, i is ke e BEF	it enat ept in R test,	oles th the l	ne BEI BER I	Receiv	/er Ér	ror (E	BRER	[n]) regi	ster. U	The bit pon the st be set
Note: [n] d	enotes inpu	ut strea	am from	0 - 15												

Table 27 - BER Receiver Control Register [n] (BRCR[n]) Bits

	nal Read Value: (	l Address )000 <sub>H</sub>	s: 03	860 <sub>H</sub> ·	- 036F <sub>H</sub>											
15	14	13	1	12	11	10	9	8	7	6	5	4	3	2	1	0
ST[n] BC15	ST[n] BC14	ST[n] BC13		T[n] C12	ST[n] BC11	ST[n] BC10	ST[n] BC9	ST[n] BC8	ST[n] BC7	ST[n] BC6	ST[n] BC5	ST[n] BC4	ST[n] BC3	ST[n] BC2	ST[n] BC1	ST[n] BC0
			•													
Bit		Name	Description													
15 - 0		ST[n] C15 - 0	)	Th	e binar	y value	e of the		refers	• •				n it rea	iches it	s maxi-
Note: [n]	denote	s input s	trea	am fr	om 0 - 1	5.										

## Table 28 - BER Receiver Error Register [n] (BRER[n]) Bits - Read Only

## 20.0 Memory

## 20.1 Memory Address Mappings

When A13 is high, the data or connection memory can be accessed by the microprocessor port. Bit 1 - 0 in the Control Register determine the access to the data or connection memory ( $CM_L$  or  $CM_H$ ).

MSB (Note 1)				am Add St0 - 15								annel A (Ch0 -		S	
A13	A12	A11	A10	A9	<b>A</b> 8	Stream [n]	A7	A6	A5	A4	A3	A2	A1	A0	Channel [n]
1 1 1 1 1 1	0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	0 0 0 0 0 0 0 1 1 1	0 0 0 1 1 1 1 0 1 1	0 0 1 0 0 1 1 1	0 1 0 1 0 1 0 0 1	Stream 0 Stream 1 Stream 2 Stream 3 Stream 4 Stream 5 Stream 6 Stream 7 Stream 8 Stream 14 Stream 15	0 0 0 0 0 0 0 0 0 0 0	0 0 0 0 0 1 1 1	0 0 0 0 1 1 1 1	0 0 1 1 0 0 1 1 1 1 1 1 1	0 0 1 1 0 0	0 0 1 1 0 0 1 1 1 1 1	0 0 1 1 0 0 1 1 1 1 1 1 1	0 1 0 1 0 1 0 1 0 1 0 1 0 1	Ch 0 Ch 1 · · · Ch 30 Ch 31 (Note 2) Ch 32 Ch 33 · · Ch 62 Ch 63 (Note 3) · · · · · · · · · · · · · · · · · · ·
Note 1:		:A13 m al regis		high fo	or acce	ss to data and	d conr	nectio	n men	nory p	ositio	ns. A1	3 mu	st be l	ow to access
Note 2: Note 3: Note 4:	Chanr Chanr	nels 0 t nels 0 t	o 31 aı o 63 aı	e usec	l when	serial stream serial stream n serial strear	is at -	4.096	Mbps	-					
Note 5:	Chanr	nels 0 t	o 255 a	are use	d whe	n serial strear	n is a	t 16.3	34 Mb	ps.					

Table 29 - Addr	ess Map for Me	emory Location	s (A13 = 1)
-----------------	----------------	----------------	-------------

## 20.2 Connection Memory Low (CM\_L) Bit Assignment

When the CMM bit (bit 0) in the connection memory low is zero, the per-channel transmission is set to the normal channel-switching. The connection memory low bit assignment for the channel transmission mode is shown in Table 30 on page 55.

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
UA EN	V/C	0	SSA         SSA         SSA         SSA         SCA         SCA <th>SCA 0</th> <th>CMM =0</th>											SCA 0	CMM =0
Bit	Name Description														
15	U	IAEN	Wh tior Wh	Conversion between $\mu$ -law and A-law Enable When this bit is low, normal switch without $\mu$ -law/A-law conversion. Connection memory high will be ignored. When this bit is high, switch with $\mu$ -law/A-law conversion, and connection memory high controls the conversion method.											
14	,	V/C	Wh sta	nen thi nt dela	s bit is ay mei	s low, t mory.	elay (	tput da	ata for						ı con-
				iable o			ry. Not								
13	Ur	nused	var firs	iable ( t.	delay ı	memo		te that	VARE	EN mu	st be s	set in (	Contro	l Regi	
13 12 - 9		nused SA3 - 0	var firs Re So	iable ( t. serve urce \$	delay i d. In n Strean	nemo ormal n Add	ry. Not	te that onal m	VARE	EN mu	st be s bits <b>M</b>	set in ( UST b	Contro e set f	ol Regi to zerc	ster
-	SS		var firs Re So The So	iable ( t. serve urce \$ e bina urce (	delay i d. In n Strean ry valu Chann	memo ormal n Add ue of th nel Ad	ry. Not function ress	te that onal m	VARE node, t	EN mus these l	st be s bits <b>M</b> e inpu	set in ( UST b t strea	Contro e set 1 am nur	to zero	ster

Table 30 - Connection Memory Low (CM\_L) Bit Assignment when CMM = 0

When CMM is one, the device is programmed to perform one of the special per-channel transmission modes. Bits PCC0 and PCC1 from connection memory are used to select the per-channel tristate, message or BER test mode as shown in Table 31 on page 56.

	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
UA EN	0	0	0	0	MSG 7	MSG 6	MSG 5	MSG 4	MSG 3	MSG 2	MSG 1	MSG 0	PCC 1	PCC 0	CMM =1
Bit		Nam	е						De	scripti	on				
15		UAE	N	Wh tior Wh	nen this n mem nen this	s bit is ory hig s bit is	low, m jh will l high, r	essage be igno	e mode red. je mod	e has n le has	ο μ-lav μ-law//	v/A-lav A-law c		ersion.	<b>Ily)</b> Connec nd con-
14 - 11	ι	Jnus	ed	-	<b>serve</b> normal		onal m	ode, th	ese bi	ts MUS	ST be s	set to z	ero.		
10 - 3	М	ISG7	- 0	8-b	<b>ssage</b> it data R test	for the	e mess	age m	ode. N	ot use	d in the	e per-c	hannel	tristate	e and
2 - 1	Р	CC1	- 0				ontrol	Bits the co	rrespo	ndina e	entrv's	value (	on the	STio si	
				Th	ese two	0 0113 0			ncopo	iung c	Jind y C	value		0110 3	tream.
				Th			PC C1	PC C0	•	0	Output				tream.
				Th			PC	PC	C	hannel		Mode		0110 3	tream.
				Th			PC C1	PC C0	C	hannel Per Cha	Output	Mode istate			tream.
				Th			PC C1 0	PC C0 0	C	hannel Per Cha Mess	Output	Mode istate ode			tream.
				Th			PC C1 0 0	PC C0 0	C	hannel Per Cha Mess BER	Output Innel Tr age Mc	Mode istate ode ode			tream.

Table 31 - Connection Memory Low (CM\_L) Bit Assignment when CMM = 1

## 20.3 Connection Memory High (CM\_H) Bit Assignment

Connection memory high provides the detailed information required for  $\mu$ -law and A-law conversion. ICL and OCL bits describe the Input Coding Law and the Output Coding Law, respectively. They are used to select the expected PCM coding laws for the connection, on the TDM inputs, and on the TDM outputs. The  $\overline{V}/D$  bit is used to select the class of coding law. If the  $\overline{V}/D$  bit is cleared (to select a voice connection), the ICL and OCL bits select between A-law and  $\mu$ -law specifications related to G.711 voice coding. If the  $\overline{V}/D$  bit is select a data connection), the ICL and OCL bits select between various bit inverting protocols. These coding laws are illustrated in the following table. If the ICL is different than the OCL, all data bytes passing through the switch on that particular connection are translated between the indicated laws. If the ICL and the OCL are the same, no coding law translation is performed.

The ICL, the OCL bits and  $\overline{V}/D$  bit only have an effect on PCM code translations for constant delay connections, variable delay connections and per-channel message mode.

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	V/D	ICL 1	ICL 0	OCL 1	OCI 0
Bit	N	ame							Descri	ption					
15 - 5	Ur	nused	-	<b>serve</b> norma	e <b>d</b> al funct	ional	mode,	these	bits <b>N</b>	IUST	be set	to zer	0.		
4	Ň	V/D	Wh	nen th		low,	trol ow, the corresponding channel is for voice. high, the corresponding channel is for data.								
3 - 2	ICI	L1 - 0	Inp	out Co	oding	_aw.									
									Input	Codin	g Law				
					ICL1-0	F	or Voice	e (V/D	bit = 0)	)	For Da	ata (V/I	) bit =	1)	
				-	00		CCITI	.ITU A	-law			No co	de		
					01		CCITI	Γ.ITU μ	-law	ABI					
					10		A-lav	w w/o A	ABI		In	verted	ABI		
					11	Ļ	ι-law w In	/o Mag versior			All	Bits Inv	/erted		
1 - 0	oc	L1 - 0	Ou	tput	Coding	g Law	,								
					0014	0			Outpu	ıt Codi	ng Law	/			
					OCL1-		For Voi	ce (V/D	) bit = (	D)	For Da	ata (∇/C	) bit =	1)	
					00		CCIT	T.ITU	A-law			No coc	le		
					01		CCIT	T.ITU	μ-law			ABI			
					10		A-la	aw w/o	ABI		In	verted	ABI		
					11		μ-law v I	v/o Ma nversio	•	e	All I	Bits Inv	rerted		

## Table 32 - Connection Memory High (CM\_H) Bit Assignment

## 21.0 DC Parameters

#### **Absolute Maximum Ratings\***

	Parameter	Symbol	Min.	Max.	Units
1	I/O Supply Voltage	V <sub>DD_IO</sub>	-0.5	5.0	V
2	Core Supply Voltage	V <sub>DD_CORE</sub>	-0.5	2.5	V
3	Input Voltage	V <sub>I_3V</sub>	-0.5	V <sub>DD</sub> + 0.5	V
4	Input Voltage (5 V-tolerant inputs)	V <sub>I_5V</sub>	-0.5	7.0	V
5	Continuous Current at Digital Outputs	Ι <sub>ο</sub>		15	mA
6	Package Power Dissipation	P <sub>D</sub>		1.5	W
7	Storage Temperature	Τ <sub>S</sub>	- 55	+125	°C

\* Exceeding these values may cause permanent damage. Functional operation under these conditions is not implied.

#### Recommended Operating Conditions - Voltages are with respect to ground (V<sub>SS</sub>) unless otherwise stated.

	Characteristics	Sym.	Min.	Typ.‡	Max.	Units
1	Operating Temperature	T <sub>OP</sub>	-40	25	+85	°C
2	Positive Supply	V <sub>DD_IO</sub>	3.0	3.3	3.6	V
3	Positive Supply	$V_{DD_{CORE}}$	1.71	1.8	1.89	V
4	Input Voltage	VI	0	3.3	V <sub>DD_IO</sub>	V
5	Input Voltage on 5 V-Tolerant Inputs	V <sub>I_5V</sub>	0	5.0	5.5	V

<sup>‡</sup> Typical figures are at 25°C and are for design aid only: not guaranteed and not subject to production testing.

## **DC Electrical Characteristics**<sup>†</sup> - Voltages are with respect to ground (V<sub>ss</sub>) unless otherwise stated.

	Characteristics	Sym.	Min.	Typ.‡	Max.	Units	Test Conditions
1	Supply Current - V <sub>DD_CORE</sub>	I <sub>DD_CORE</sub>			115	mA	
2	Supply Current - V <sub>DD_IO</sub>	I <sub>DD_IO</sub>			40	mA	C <sub>L</sub> =30pF
3	Input High Voltage	V <sub>IH</sub>	2.0			V	
4	Input Low Voltage	V <sub>IL</sub>			0.8	V	
5	Input Leakage (input pins) Input Leakage (bi-directional pins)	I <sub>IL</sub> I <sub>BL</sub>			5 5	μ <b>Α</b> μ <b>Α</b>	0≤ <v<sub>IN≤V<sub>DD_IO</sub> See Note 1</v<sub>
6	Weak Pullup Current	I <sub>PU</sub>		-33		μA	Input at 0 V
7	Weak Pulldown Current	I <sub>PD</sub>		33		μA	Input at V <sub>DD_IO</sub>
8	Input Pin Capacitance	Cl		3		pF	
9	Output High Voltage	V <sub>OH</sub>	2.4			V	I <sub>OH</sub> = 8 mA
10	Output Low Voltage	V <sub>OL</sub>			0.4	V	I <sub>OL</sub> = 8 mA
11	Output High Impedance Leakage	I <sub>OZ</sub>			5	μA	0 < V < V <sub>DD</sub>
12	Output Pin Capacitance	C <sub>O</sub>		5	10	pF	

† Characteristics are over recommended operating conditions unless otherwise stated.

<sup>‡</sup> Typical figures are at 25°C, VDD\_CORE at 1.8 V and VDD\_IO at 3.3 V and are for design aid only: not guaranteed and not subject to production testing.

\* Note 1: Maximum leakage on pins (output or I/O pins in high impedance state) is over an applied voltage ( $V_{IN}$ ).

## 22.0 AC Parameters

AC Electrical Characteristics<sup>†</sup> - Timing Parameter Measurement Voltage Levels

	Characteristics	Sym.	Level	Units	Conditions
1	CMOS Threshold	V <sub>CT</sub>	0.5 V <sub>DD_IO</sub>	V	
2	Rise/Fall Threshold Voltage High	V <sub>HM</sub>	0.7 V <sub>DD_IO</sub>	V	
3	Rise/Fall Threshold Voltage Low	$V_{LM}$	0.3 V <sub>DD_IO</sub>	V	

† Characteristics are over recommended operating conditions unless otherwise stated.

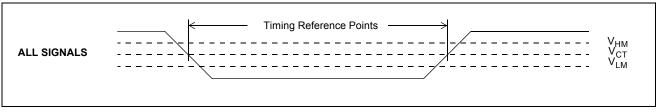
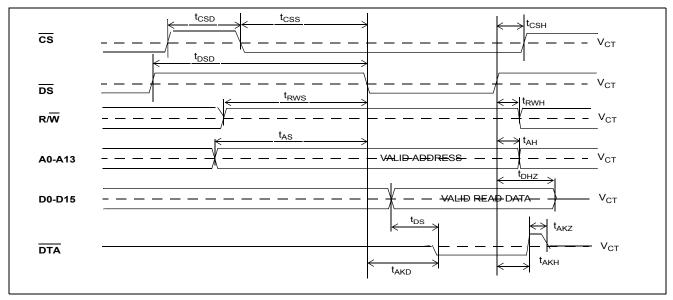


Figure 19 - Timing Parameter Measurement Voltage Levels

	Characteristics	Sym.	Min.	Typ.‡	Max.	Units	Test Conditions <sup>2</sup>
1	CS de-asserted time	t <sub>CSD</sub>	15			ns	
2	DS de-asserted time	t <sub>DSD</sub>	15			ns	
3	CS setup to DS falling	t <sub>CSS</sub>	0			ns	
4	$R/\overline{W}$ setup to $\overline{DS}$ falling	t <sub>RWS</sub>	10			ns	
5	Address setup to $\overline{\text{DS}}$ falling	t <sub>AS</sub>	5			ns	
6	CS hold after DS rising	t <sub>CSH</sub>	0			ns	
7	R/W hold after DS rising	t <sub>RWH</sub>	0			ns	
8	Address hold after DS rising	t <sub>AH</sub>	0			ns	
9	Data setup to DTA Low	t <sub>DS</sub>	8			ns	C <sub>L</sub> = 50 pF
10	Data Active to High Impedance	t <sub>DHZ</sub>			8	ns	C <sub>L</sub> = 50 pF, R <sub>L</sub> = 1 K (Note 1)
11	Ackno <u>wle</u> dgeme <u>nt d</u> elay time. From DS low to DTA low: Registers Memory	t <sub>AKD</sub>			75 185	ns ns	C <sub>L</sub> = 50 pF C <sub>L</sub> = 50 pF
12	Acknowledgement hold time. From DS high to DTA high	t <sub>AKH</sub>	4		12	ns	C <sub>L</sub> = 50 pF, R <sub>L</sub> = 1 K (Note 1)
13	DTA drive high to HiZ	t <sub>AKZ</sub>			8	ns	
lote lote	discharge C <sub>L</sub> .	13.2 on pag		_	-		

## AC Electrical Characteristics<sup>†</sup> - Motorola Non-Multiplexed Bus Mode - Read Access

the set of the se



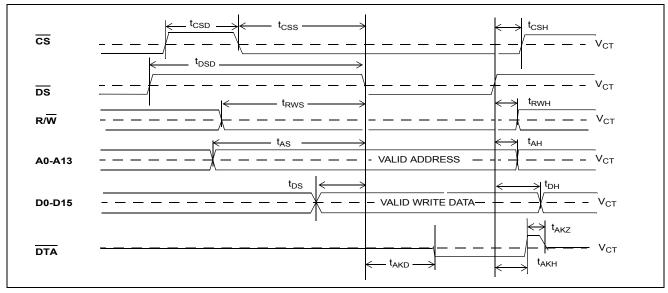


	Characteristics	Sym.	Min.	Typ.‡	Max.	Units	Test Conditions <sup>2</sup>
1	CS de-asserted time	t <sub>CSD</sub>	15			ns	
2	DS de-asserted time	t <sub>DSD</sub>	15			ns	
3	CS setup to DS falling	t <sub>CSS</sub>	0			ns	
4	$R/\overline{W}$ setup to $\overline{DS}$ falling	t <sub>RWS</sub>	10			ns	
5	Address setup to DS falling	t <sub>AS</sub>	5			ns	
6	Data setup to DS falling	t <sub>DS</sub>	0			ns	C <sub>L</sub> = 50 pF
7	CS hold after DS rising	t <sub>CSH</sub>	0			ns	
8	R/W hold after DS rising	t <sub>RWH</sub>	0			ns	
9	Address hold after DS rising	t <sub>AH</sub>	0			ns	
10	Data hold from $\overline{\text{DS}}$ rising	t <sub>DH</sub>	5			ns	C <sub>L</sub> = 50 pF, R <sub>L</sub> = 1 K (Note 1)
11	Acknowledgeme <u>nt d</u> elay time. From DS low to DTA low: Registers Memory	t <sub>AKD</sub>			55 150	ns ns	C <sub>L</sub> = 50 pF C <sub>L</sub> = 50 pF
12	Acknowledgemen <u>t ho</u> ld time. From DS high to DTA high	t <sub>AKH</sub>	4		12	ns	C <sub>L</sub> = 50 pF, R <sub>L</sub> = 1 K (Note 1)
13	DTA drive high to HiZ	t <sub>AKZ</sub>			8	ns	

## AC Electrical Characteristics<sup>†</sup> - Motorola Non-Multiplexed Bus Mode - Write Access

performed after the RESET pin is set high.

† Characteristics are over recommended operating conditions unless otherwise stated.

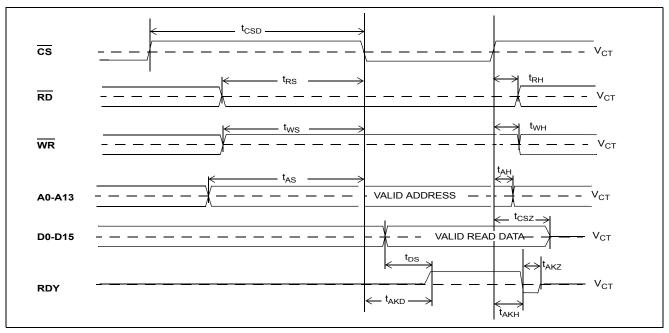




erted time $\overline{OCS}$ falling $\overline{OCS}$ falling tup to $\overline{CS}$ falling er $\overline{CS}$ rising ter $\overline{CS}$ rising Id after $\overline{CS}$ rising to RDY high	t <sub>CSD</sub> t <sub>RS</sub> t <sub>WS</sub> t <sub>AS</sub> t <sub>RH</sub> t <sub>WH</sub> t <sub>AH</sub>	15 10 10 5 0 0 0			ns ns ns ns ns ns	
o $\overline{CS}$ falling tup to $\overline{CS}$ falling er $\overline{CS}$ rising ter $\overline{CS}$ rising Id after $\overline{CS}$ rising to RDY high	t <sub>WS</sub> t <sub>AS</sub> t <sub>RH</sub> t <sub>WH</sub> t <sub>AH</sub>	10 5 0 0			ns ns ns	
tup to $\overline{CS}$ falling er $\overline{CS}$ rising ter $\overline{CS}$ rising Id after $\overline{CS}$ rising to RDY high	t <sub>AS</sub> t <sub>RH</sub> t <sub>WH</sub> t <sub>AH</sub>	5 0 0			ns ns	
er CS rising ter CS rising Id after CS rising to RDY high	t <sub>RH</sub> t <sub>WH</sub> t <sub>AH</sub>	0			ns	
ter CS rising Id after CS rising to RDY high	t <sub>WH</sub> t <sub>AH</sub>	0			-	
ld after CS rising to RDY high	t <sub>AH</sub>	-			ns	
to RDY high		0				
•	tpe				ns	
to I link lange adamses	5US	8			ns	C <sub>L</sub> = 50 pF
to High Impedance	t <sub>CSZ</sub>	7			ns	C <sub>L</sub> = 50 pF, R <sub>L</sub> = 1 K (Note 1)
gement delay time. w to RDY high:	t <sub>AKD</sub>			175 185	ns ns	C <sub>L</sub> = 50 pF C <sub>L</sub> = 50 pF
gement hold time. gh to RDY low	t <sub>AKH</sub>	4		12	ns	C <sub>L</sub> = 50 pF, R <sub>L</sub> = 1 K (Note 1)
ow to HiZ	t <sub>AKZ</sub>			8	ns	
	gh to RDY low ow to HiZ edance is measured by pullir C <sub>L</sub> .	gh to RDY low ow to HiZ t <sub>AKZ</sub> edance is measured by pulling to the app C <sub>L</sub> .	gh to RDY low ow to HiZ t <sub>AKZ</sub> edance is measured by pulling to the appropriate ra	gh to RDY low     AKh       ow to HiZ     t <sub>AKZ</sub> edance is measured by pulling to the appropriate rail with R <sub>L</sub> , w       C <sub>L</sub> .       f 500 μs to 2 ms (see Section 13.2 on page 32) must be applied	gement hold time.     t <sub>AKH</sub> 4     12       gh to RDY low     t <sub>AKZ</sub> 8       ow to HiZ     t <sub>AKZ</sub> 8       edance is measured by pulling to the appropriate rail with R <sub>L</sub> , with timing of C <sub>L</sub> .	gement hold time.       t <sub>AKH</sub> 4       12       ns         gh to RDY low       t <sub>AKZ</sub> 4       12       ns         ow to HiZ       t <sub>AKZ</sub> 8       ns         edance is measured by pulling to the appropriate rail with R <sub>L</sub> , with timing corrected to C <sub>L</sub> .       500 µs to 2 ms (see Section 13.2 on page 32) must be applied before the first micro

## AC Electrical Characteristics<sup>†</sup> - Intel Non-Multiplexed Bus Mode - Read Access

+ Characteristics are over recommended operating conditions unless otherwise stated.

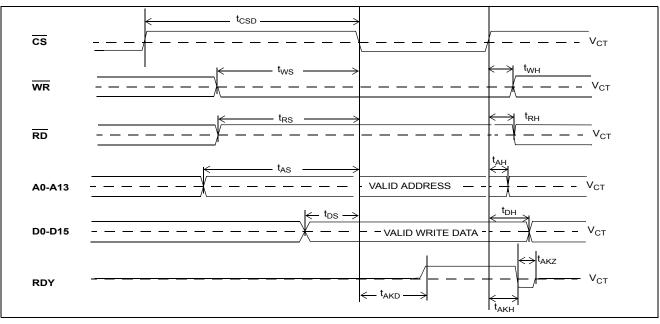


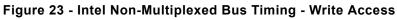


serted time to $\overline{CS}$ falling to $\overline{CS}$ falling setup to $\overline{CS}$ falling p to $\overline{CS}$ falling after $\overline{CS}$ rising ofter $\overline{CS}$ rising	t <sub>CSD</sub> t <sub>WS</sub> t <sub>RS</sub> t <sub>AS</sub> t <sub>DS</sub> t <sub>WH</sub>	15 10 10 5 0 0			ns ns ns ns	
to $\overline{CS}$ falling setup to $\overline{CS}$ falling p to $\overline{CS}$ falling after $\overline{CS}$ rising ofter $\overline{CS}$ rising	t <sub>RS</sub> t <sub>AS</sub> t <sub>DS</sub> t <sub>WH</sub>	10 5 0			ns ns	
betup to $\overline{CS}$ falling p to $\overline{CS}$ falling after $\overline{CS}$ rising after $\overline{CS}$ rising	t <sub>AS</sub> t <sub>DS</sub> t <sub>WH</sub>	5 0			ns	
p to CS falling after CS rising after CS rising	t <sub>DS</sub> t <sub>WH</sub>	0			-	
after CS rising	t <sub>WH</sub>	-				
Ifter CS rising		0			ns	C <sub>L</sub> = 50 pF
	1	U U			ns	
	t <sub>RH</sub>	0			ns	
old after CS rising	t <sub>AH</sub>	10			ns	
after $\overline{CS}$ rising	t <sub>DH</sub>	5			ns	C <sub>L</sub> = 50 pF, R <sub>L</sub> = 1 K (Note 1)
dgement delay time. low to RDY high: rs	t <sub>AKD</sub>			55 150	ns ns	C <sub>L</sub> = 50 pF C <sub>L</sub> = 50 pF
dgement hold time. high to RDY low	t <sub>AKH</sub>	4		12	ns	C <sub>L</sub> = 50 pF, R <sub>L</sub> = 1 K (Note 1)
e low to HiZ	t <sub>AKZ</sub>			8	ns	
	dgement hold time. high to RDY low e low to HiZ pedance is measured by pullir ge C <sub>L</sub> .	dgement hold time. high to RDY low e low to HiZ t <sub>AKZ</sub> pedance is measured by pulling to the appr ge C <sub>L</sub> . of 500 μs to 2 ms (Section 13.2 on page 32)	dgement hold time. high to RDY low $t_{AKH}$ 4e low to HiZ $t_{AKZ}$ pedance is measured by pulling to the appropriate ra ge CL. of 500 µs to 2 ms (Section 13.2 on page 32) must be	dgement hold time. high to RDY low e low to HiZ t <sub>AKZ</sub> pedance is measured by pulling to the appropriate rail with R <sub>L</sub> , w ge C <sub>L</sub> . of 500 μs to 2 ms (Section 13.2 on page 32) must be applied be	dgement hold time.     t <sub>AKH</sub> 4     12       high to RDY low     t <sub>AKZ</sub> 8       e low to HiZ     t <sub>AKZ</sub> 8       pedance is measured by pulling to the appropriate rail with R <sub>L</sub> , with timing compare C <sub>L</sub> .     of 500 µs to 2 ms (Section 13.2 on page 32) must be applied before the first	dgement hold time.     t <sub>AKH</sub> 4     12     ns       high to RDY low     t <sub>AKZ</sub> 8     ns       e low to HiZ     t <sub>AKZ</sub> 8     ns

## AC Electrical Characteristics<sup>†</sup> - Intel Non-Multiplexed Bus Mode - Write Access

+ Characteristics are over recommended operating conditions unless otherwise stated.





## AC Electrical Characteristics $^{\dagger}$ - JTAG Test Port Timing

	Characteristic	Sym.	Min.	Typ.‡	Max.	Units	Notes
1	TCK Clock Period	t <sub>TCKP</sub>	100			ns	
2	TCK Clock Pulse Width High	t <sub>тскн</sub>	20			ns	
3	TCK Clock Pulse Width Low	t <sub>TCKL</sub>	20			ns	
4	TMS Set-up Time	t <sub>TMSS</sub>	10			ns	
5	TMS Hold Time	t <sub>TMSH</sub>	10			ns	
6	TDi Input Set-up Time	t <sub>TDIS</sub>	20			ns	
7	TDi Input Hold Time	t <sub>TDIH</sub>	60			ns	
8	TDo Output Delay	t <sub>TDOD</sub>			30	ns	C <sub>L</sub> = 30 pF
9	TRST pulse width	t <sub>TRSTW</sub>	200			ns	

† Characteristics are over recommended operating conditions unless otherwise stated.

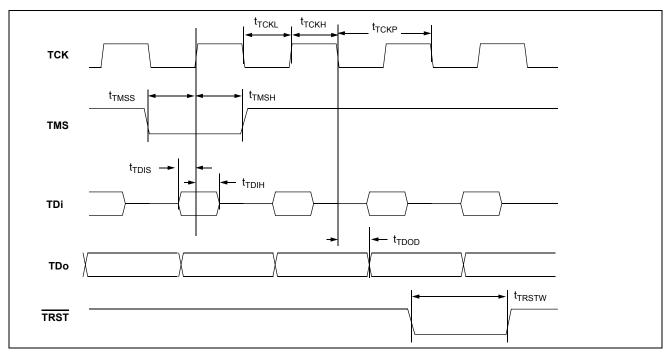


Figure 24 - JTAG Test Port Timing Diagram

	Characteristic	Sym.	Min.	Typ.‡	Max.	Units	Notes
1	FPi Input Frame Pulse Width	t <sub>FPIW</sub>	40	61	115	ns	
2	FPi Input Frame Pulse Setup Time	t <sub>FPIS</sub>	20			ns	
3	FPi Input Frame Pulse Hold Time	t <sub>FPIH</sub>	20			ns	
4	CKi Input Clock Period	t <sub>CKIP</sub>	55	61	67	ns	
5	CKi Input Clock High Time	t <sub>CKIH</sub>	27		34	ns	
6	CKi Input Clock Low Time	t <sub>CKIL</sub>	27		34	ns	
7	CKi Input Clock Rise/Fall Time	t <sub>r</sub> CKi, t <sub>f</sub> CKi			3	ns	
8	CKi Input Clock Cycle to Cycle Variation	t <sub>CVC</sub>	0		20	ns	

## AC Electrical Characteristics<sup>†</sup> - FPi and CKi Timing when CKIN1-0 bits = 00 (16.384 MHz)

† Characteristics are over recommended operating conditions unless otherwise stated.

+ Typical figures are at 25°C, VDD\_CORE at 1.8 V and VDD\_IO at 3.3 V and are for design aid only: not guaranteed and not subject to produc-tion testing.

	Characteristic	Sym.	Min.	Typ.‡	Max.	Units	Notes
1	FPi Input Frame Pulse Width	t <sub>FPIW</sub>	90	122	220	ns	
2	FPi Input Frame Pulse Setup Time	t <sub>FPIS</sub>	45			ns	
3	FPi Input Frame Pulse Hold Time	t <sub>FPIH</sub>	45			ns	
4	CKi Input Clock Period	t <sub>CKIP</sub>	110	122	135	ns	
5	CKi Input Clock High Time	t <sub>СКІН</sub>	55		69	ns	
6	CKi Input Clock Low Time	t <sub>CKIL</sub>	55		69	ns	
7	CKi Input Clock Rise/Fall Time	t <sub>r</sub> CKi, t <sub>f</sub> CKi			3	ns	
8	CKi Input Clock Cycle to Cycle Variation	t <sub>CVC</sub>	0		20	ns	

## AC Electrical Characteristics<sup>†</sup> - FPi and CKi Timing when CKIN1-0 bits = 01 (8.192 MHz)

† Characteristics are over recommended operating conditions unless otherwise stated.

	Characteristic	Sym.	Min.	Typ.‡	Max.	Units	Notes			
1	FPi Input Frame Pulse Width	t <sub>FPIW</sub>	90	244	420	ns				
2	FPi Input Frame Pulse Setup Time	t <sub>FPIS</sub>	110			ns				
3	FPi Input Frame Pulse Hold Time	t <sub>FPIH</sub>	110			ns				
4	CKi Input Clock Period	t <sub>CKIP</sub>	220	244	270	ns				
5	CKi Input Clock High Time	t <sub>скін</sub>	110		135	ns				
6	CKi Input Clock Low Time	t <sub>CKIL</sub>	110		135	ns				
7	CKi Input Clock Rise/Fall Time	t <sub>r</sub> CKi, t <sub>f</sub> CKi			3	ns				
8	CKi Input Clock Cycle to Cycle Variation	t <sub>CVC</sub>	0		20	ns				

## AC Electrical Characteristics<sup>†</sup> - FPi and CKi Timing when CKIN1-0 bits = 10 (4.096 MHz)

† Characteristics are over recommended operating conditions unless otherwise stated.

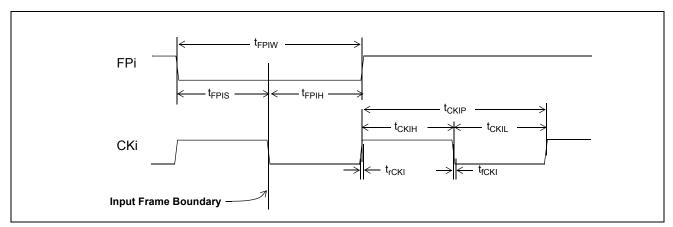


Figure 25 - Frame Pulse Input and Clock Input Timing Diagram (ST-BUS)

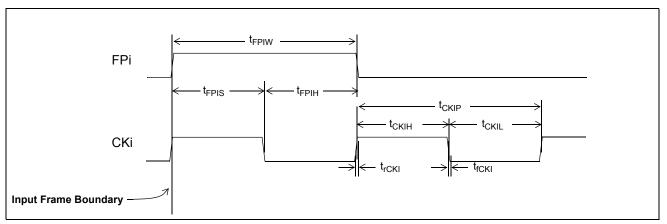


Figure 26 - Frame Pulse Input and Clock Input Timing Diagram (GCI-Bus)

AC Electrical Characteristics <sup>†</sup>	- ST-BUS/GCI-Bus Input Timing
--	-------------------------------

	Characteristic	Sym.	Min.	Typ.‡	Max.	Units	Test Conditions
1	STi Setup Time						
	2.048 Mbps 4.096 Mbps 8.192 Mbps 16.384 Mbps	t <sub>SIS2</sub> t <sub>SIS4</sub> t <sub>SIS8</sub> t <sub>SIS16</sub>	5 5 5 5			ns ns ns ns	
2	STi Hold Time						
	2.048 Mbps 4.096 Mbps 8.192 Mbps 16.384 Mbps	t <sub>SIH2</sub> t <sub>SIH4</sub> t <sub>SIH8</sub> t <sub>SIH16</sub>	8 8 8 8			ns ns ns ns	

† Characteristics are over recommended operating conditions unless otherwise stated.

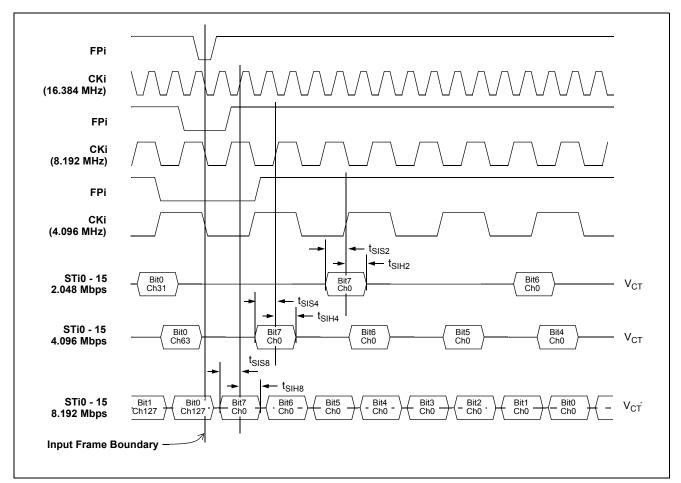


Figure 27 - ST-BUS Input Timing Diagram when Operated at 2, 4 or 8 Mbps

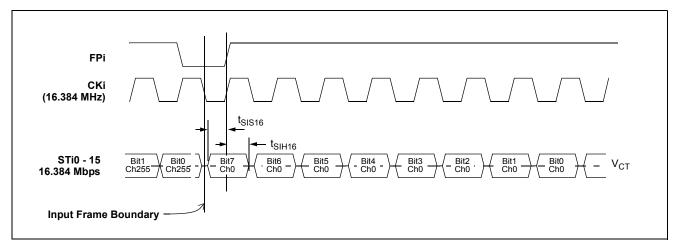


Figure 28 - ST-BUS Input Timing Diagram when Operated at 16 Mbps

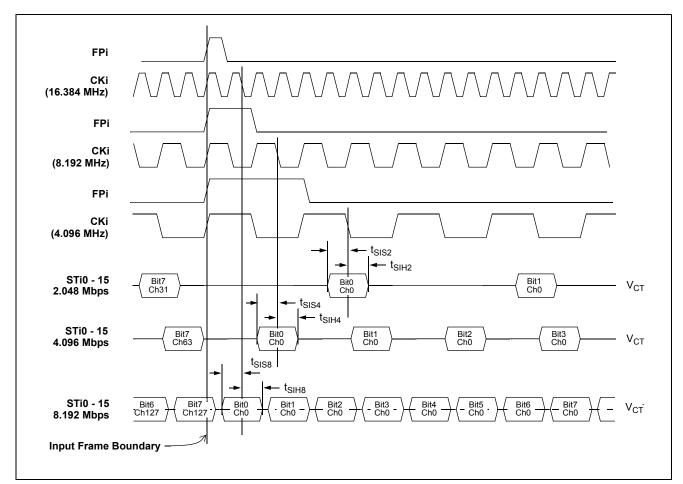


Figure 29 - GCI-Bus Input Timing Diagram when Operated at 2, 4 or 8 Mbps

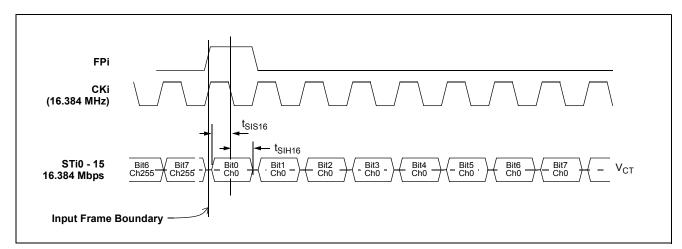


Figure 30 - GCI-Bus Input Timing Diagram when Operated at 16 Mbps

AC Electrical Characteristics <sup>†</sup> - S	ST-BUS/GCI-Bus Output Timing
--	------------------------------

	Characteristic	Sym.	Min.	Typ.‡	Max.	Units	Test Conditions
1	STio Delay - Active to Active						C <sub>L</sub> = 30 pF
	@2.048 Mbps @4.096 Mbps @8.192 Mbps @16.384 Mbps	t <sub>SOD2</sub> t <sub>SOD4</sub> t <sub>SOD8</sub> t <sub>SOD16</sub>	0 0 0 0		6 6 6	ns ns ns ns	Multiplied Clock Mode
	@2.048 Mbps @4.096 Mbps @8.192 Mbps @16.384 Mbps	t <sub>SOD2</sub> t <sub>SOD4</sub> t <sub>SOD8</sub> t <sub>SOD16</sub>	-6 -6 -6		0 0 0	ns ns ns ns	Divided Clock Mode

† Characteristics are over recommended operating conditions unless otherwise stated.

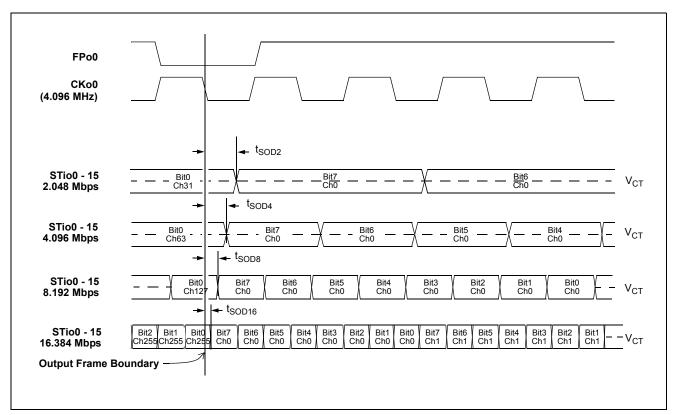


Figure 31 - ST-BUS Output Timing Diagram when Operated at 2, 4, 8 or 16 Mbps

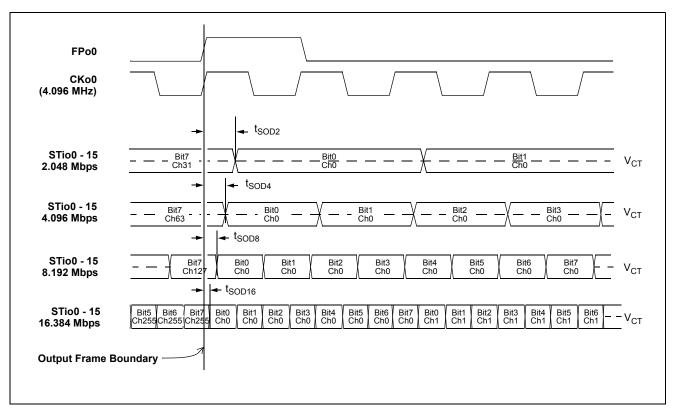


Figure 32 - GCI-Bus Output Timing Diagram when Operated at 2, 4, 8 or 16 Mbps

## AC Electrical Characteristics $^{\dagger}$ - ST-BUS/GCI-Bus Output Tristate Timing

	Characteristic	Sym.	Min.	Typ.‡	Max.	Units	Test Conditions <sup>*</sup>
1	STio Delay - Active to High-Z	t <sub>DZ</sub>	-3 -8		7 0	ns ns	Multiplied Clock Mode Divided Clock Mode
2	STio Delay - High-Z to Active	t <sub>ZD</sub>	-3 -8		7 0	ns ns	Multiplied Clock Mode Divided Clock Mode
3	Output Drive Enable (ODE) Delay - High-Z to Active	t <sub>ZD_ODE</sub>			77	ns	Multiplied Clock Mode
	CKi @ 4.096 MHz CKi @ 8.192 MHz CKi @ 16.384 MHz				260 138 77	ns ns ns	Divided Clock Mode

† Characteristics are over recommended operating conditions unless otherwise stated.

+ Typical figures are at 25°C, VDD\_CORE at 1.8 V and VDD\_IO at 3.3 V and are for design aid only: not guaranteed and not subject to production testing.

Note 1: High impedance is measured by pulling to the appropriate rail with  $R_L$ , with timing corrected to cancel the time taken to discharge  $C_L$ .

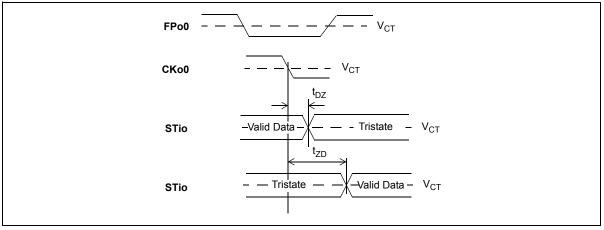


Figure 33 - Serial Output and External Control

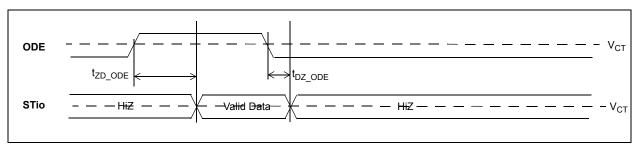


Figure 34 - Output Drive Enable (ODE)

	Characteristic	Sym.	Min.	Typ.‡	Max.	Units	Notes
1	Input and Output Frame Offset in Divided Clock Mode	<sup>t</sup> FBOS	5		13	ns	
2	Input and Output Frame Offset in Multiplied Clock Mode	t <sub>FBOS</sub>	2		10	ns	Input reference jitter is equal to zero.

† Characteristics are over recommended operating conditions unless otherwise stated.

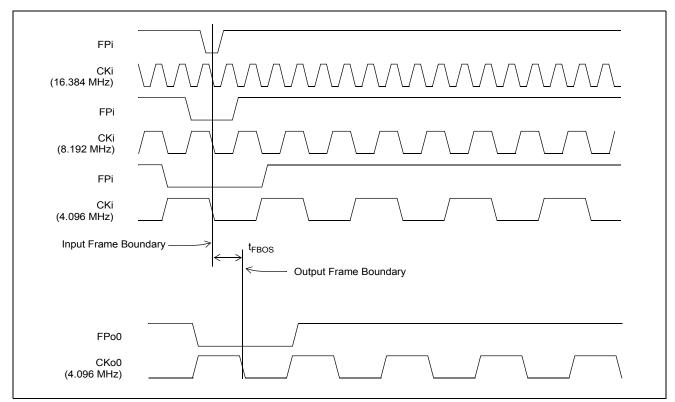
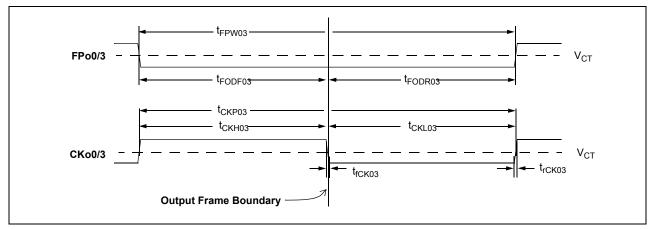
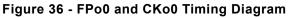


Figure 35 - Input and Output Frame Boundary Offset





AC Electrical Characteristics<sup>†</sup> - FPo0/CKo0 and FPo3/CKo3 (4.096 MHz) Timing for Divided Clock Mode and Multiplied Clock Mode with Less than 10ns of Input Cycle to Cycle Variation

	Characteristic	Sym.	Min.	Typ.‡	Max.	Units	Notes
1	FPo0 Output Pulse Width	t <sub>FPW03</sub>	239	244	249	ns	
2	FPo0 Output Delay from the FPo0 falling edge to the output frame boundary	t <sub>FODF03</sub>	117		127	ns	C <sub>L</sub> = 30 pF
3	FPo0 Output Delay from the output frame boundary to the FPo0 rising edge	t <sub>FODR03</sub>	117		127	ns	
4	CKo0 Output Clock Period	t <sub>CKP03</sub>	239	244	249	ns	
5	CKo0 Output High Time	t <sub>CKH03</sub>	117		127	ns	C <sub>L</sub> = 30 pF
6	CKo0 Output Low Time	t <sub>CKL03</sub>	117		127	ns	
7	CKo0 Output Rise/Fall Time	t <sub>rCK03</sub> , t <sub>fCK03</sub>			5	ns	

† Characteristics are over recommended operating conditions unless otherwise stated.

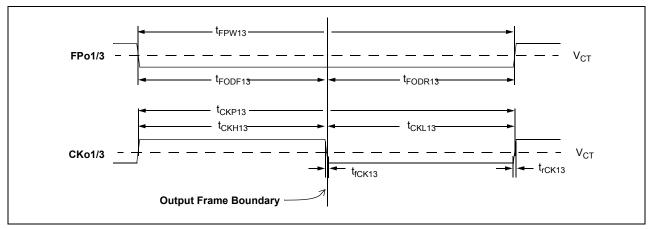
.

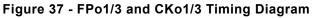
+ Typical figures are at 25°C, VDD\_CORE at 1.8 V and VDD\_IO at 3.3 V and are for design aid only: not guaranteed and not subject to production testing.

AC Electrical Characteristics <sup>†</sup> - FPo0/CKo0 and FPo3/CKo3 (4.096 MHz) Timing for Multiplied Clock Mode with More than 10 r	S
of Input Cycle to Cycle Variation	

	Characteristic	Sym.	Min.	Typ.‡	Max.	Units	Notes
1	FPo0 Output Pulse Width	t <sub>FPW03</sub>	218	244	270	ns	
2	FPo0 Output Delay from the FPo0 falling edge to the output frame boundary	t <sub>FODF03</sub>	117		127	ns	C <sub>L</sub> = 30 pF
3	FPo0 Output Delay from the output frame boundary to the FPo0 rising edge	t <sub>FODR03</sub>	97		146	ns	
4	CKo0 Output Clock Period	t <sub>CKP03</sub>	218	244	270	ns	
5	CKo0 Output High Time	t <sub>CKH03</sub>	117		127	ns	C <sub>L</sub> = 30 pF
6	CKo0 Output Low Time	t <sub>CKL03</sub>	97		146	ns	
7	CKo0 Output Rise/Fall Time	t <sub>rCK03</sub> , t <sub>fCK03</sub>			5	ns	

† Characteristics are over recommended operating conditions unless otherwise stated.





AC Electrical Characteristics<sup>†</sup> - FPo1/CKo1 and FPo3/CKo3 (8.192 MHz) Timing for Divided Clock Mode and Multiplied Clock Mode with Less than 10 ns of Input Cycle to Cycle Variation

	Characteristic	Sym.	Min.	Typ.‡	Max.	Units	Notes
1	FPo1 Output Pulse Width	t <sub>FPW13</sub>	117	122	127	ns	
2	FPo1 Output Delay from the FPo1 falling edge to the output frame boundary	t <sub>FODF13</sub>	56		66	ns	C <sub>L</sub> = 30 pF
3	FPo1 Output Delay from the output frame boundary to the FPo1 rising edge	t <sub>FODR13</sub>	56		66	ns	
4	CKo1 Output Clock Period	t <sub>CKP13</sub>	117	122	127	ns	
5	CKo1 Output High Time	t <sub>CKH13</sub>	56		66	ns	C <sub>L</sub> = 30 pF
6	CKo1 Output Low Time	t <sub>CKL13</sub>	56		66	ns	
7	CKo1 Output Rise/Fall Time	t <sub>rCK13</sub> , t <sub>fCK13</sub>			5	ns	

† Characteristics are over recommended operating conditions unless otherwise stated.

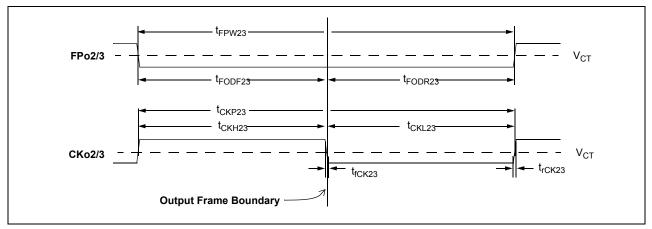
.

+ Typical figures are at 25°C, VDD\_CORE at 1.8 V and VDD\_IO at 3.3 V and are for design aid only: not guaranteed and not subject to production testing.

AC Electrical Characteristics	- FPo1/CKo1 and FPo3/CKo3 (8.192 MHz) Timing for Multiplied Clock Mode with More than 10ns
of Input Cycle to Cycle Variation	

	Characteristic	Sym.	Min.	Typ.‡	Max.	Units	Notes
1	FPo1 Output Pulse Width	t <sub>FPW13</sub>	106	122	127	ns	
2	FPo1 Output Delay from the FPo1 falling edge to the output frame boundary	t <sub>FODF13</sub>	56		66	ns	C <sub>L</sub> = 30 pF
3	FPo1 Output Delay from the output frame boundary to the FPo1 rising edge	t <sub>FODR13</sub>	46		66	ns	
4	CKo1 Output Clock Period	t <sub>CKP13</sub>	106	122	148	ns	
5	CKo1 Output High Time	t <sub>СКН13</sub>	46		87	ns	C <sub>L</sub> = 30 pF
6	CKo1 Output Low Time	t <sub>CKL13</sub>	46		66	ns	
7	CKo1 Output Rise/Fall Time	t <sub>rCK13</sub> , t <sub>fCK13</sub>			5	ns	

† Characteristics are over recommended operating conditions unless otherwise stated.





AC Electrical Characteristics<sup>†</sup> - FPo2/CKo2 and FPo3/CKo3 (16.384 MHz) Timing for Divided Clock Mode and Multiplied Clock Mode with Less than 10 ns of Input Cycle to Cycle Variation

	Characteristic	Sym.	Min.	Typ.‡	Max.	Units	Notes
1	FPo2 Output Pulse Width	t <sub>FPW23</sub>	56	61	66	ns	
2	FPo2 Output Delay from the FPo2 falling edge to the output frame boundary	t <sub>FODF23</sub>	25		36	ns	C <sub>L</sub> = 30 pF
3	FPo2 Output Delay from the output frame boundary to the FPo2 rising edge	t <sub>FODR23</sub>	25		36	ns	
4	CKo2 Output Clock Period	t <sub>CKP23</sub>	56	61	66	ns	
5	CKo2 Output High Time	t <sub>CKH23</sub>	25		36	ns	C <sub>L</sub> = 30 pF
6	CKo2 Output Low Time	t <sub>CKL23</sub>	25		36	ns	
7	CKo2 Output Rise/Fall Time	$t_{rCK23}, t_{fCK23}$			5	ns	

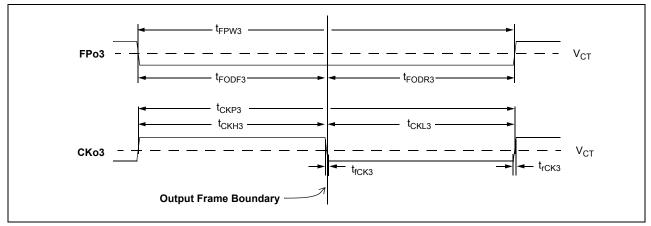
† Characteristics are over recommended operating conditions unless otherwise stated.

‡ Typical figures are at 25°C, VDD\_CORE at 1.8 V and VDD\_IO at 3.3 V and are for design aid only: not guaranteed and not subject to production testing.

AC Electrical Characteristics <sup>†</sup> - FPo	2 and FPo3/CKo3 (16.384 MHz) Timing for Multiplied Clock Mode with More than
10 ns of Input Cycle to Cycle Variation	

	Characteristic	Sym.	Min.	Typ.‡	Max.	Units	Notes
1	FPo2 Output Pulse Width	t <sub>FPW23</sub>	56	61	66	ns	
2	FPo2 Output Delay from the FPo2 falling edge to the output frame boundary	t <sub>FODF23</sub>	25		36	ns	C <sub>L</sub> = 30 pF
3	FPo2 Output Delay from the output frame boundary to the FPo2 rising edge	t <sub>FODR23</sub>	25		36	ns	
4	CKo2 Output Clock Period	t <sub>CKP2</sub>	47	61	76	ns	
5	CKo2 Output High Time	t <sub>CKH23</sub>	17		43	ns	C <sub>L</sub> = 30 pF
6	CKo2 Output Low Time	t <sub>CKL23</sub>	17		43	ns	
7	CKo2Output Rise/Fall Time	t <sub>rCK23</sub> , t <sub>fCK23</sub>			5	ns	

† Characteristics are over recommended operating conditions unless otherwise stated.





## AC Electrical Characteristics<sup>†</sup> - FPo3/CKo3 (32.768 MHz) Timing for Divided Clock Mode and Multiplied Clock Mode with Less than 10 ns of Input Cycle to Cycle Variation

	Characteristic	Sym.	Min.	Typ.‡	Max.	Units	Notes
1	FPo3 Output Pulse Width	t <sub>FPW3</sub>	27	30.5	34	ns	
2	FPo3 Output Delay from the FPo3 falling edge to the output frame boundary	t <sub>FODF3</sub>	10		18	ns	C <sub>L</sub> = 30 pF
3	FPo3 Output Delay from the output frame boundary to the FPo3 rising edge	t <sub>FODR3</sub>	12		21	ns	
4	CKo3 Output Clock Period	t <sub>CKP3</sub>	27	30.5	34	ns	
5	CKo3 Output High Time	t <sub>СКНЗ</sub>	12		19	ns	C <sub>L</sub> = 30 pF
6	CKo3 Output Low Time	t <sub>CKL3</sub>	12		19	ns	
7	CKo3 Output Rise/Fall Time	t <sub>rCK3</sub> , t <sub>fCK3</sub>			5	ns	

† Characteristics are over recommended operating conditions unless otherwise stated.

‡ Typical figures are at 25°C, VDD\_CORE at 1.8 V and VDD\_IO at 3.3 V and are for design aid only: not guaranteed and not subject to production testing.

AC Electrical Characteristics	- FPo3/CKo3 (32.768 MHz) Timing for Multiplied Clock Mode with More than 10 ns of Input Cycle
to Cycle Variation	

	Characteristic	Sym.	Min.	Typ.‡	Max.	Units	Notes
1	FPo3 Output Pulse Width	t <sub>FPW3</sub>	27	30.5	34	ns	
2	FPo3 Output Delay from the FPo3 falling edge to the output frame boundary	t <sub>FODF3</sub>	12		19	ns	C <sub>L</sub> = 30 pF
3	FPo3 Output Delay from the output frame boundary to the FPo3 rising edge	t <sub>FODR3</sub>	12		19	ns	
4	CKo3 Output Clock Period	t <sub>CKP3</sub>	17	30.5	44	ns	
5	CKo3 Output High Time	t <sub>СКНЗ</sub>	5		29	ns	C <sub>L</sub> = 30 pF
6	CKo3 Output Low Time	t <sub>CKL3</sub>	12		18	ns	
7	CKo3 Output Rise/Fall Time	t <sub>rCK3</sub> , t <sub>fCK3</sub>			5	ns	

† Characteristics are over recommended operating conditions unless otherwise stated.

## AC Electrical Characteristics $^{\dagger}$ - Divided Clock Mode Output Timing

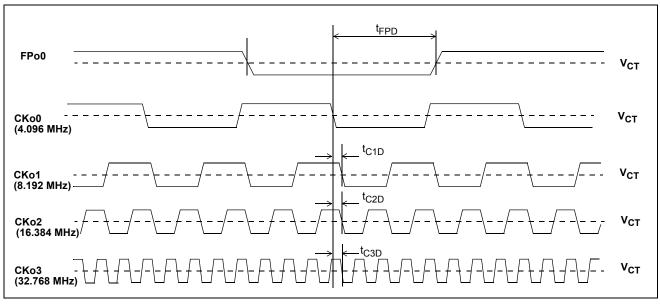
	Characteristic	Sym.	Min.	Max.	Units
1	CKo0 to CKo1 (8.192 MHz) delay	t <sub>C1D</sub>	-1	2	ns
2	CKo0 to CKo2 (16.384 MHz) delay	t <sub>C2D</sub>	-1	3	ns
3	CKo0 to CKo3 (16.384 MHz/8.192 MHz/4.096 MHz) delay	t <sub>C3D</sub>	-2	2	ns

† Characteristics are over recommended operating conditions unless otherwise stated.

#### AC Electrical Characteristics<sup>†</sup> - Multiplied Clock Mode Output Timing

	Characteristic	Sym.	Min.	Max.	Units
1	CKo0 to CKo1 (8.192 MHz) delay	t <sub>C1D</sub>	-1	2	ns
2	CKo0 to CKo2 (16.384 MHz) delay	t <sub>C2D</sub>	-1	3	ns
3	CKo0 to CKo3 (32.768 MHz/16.384 MHz/8.192 MHz/4.096 MHz) delay	t <sub>C3D</sub>	-1	3	ns

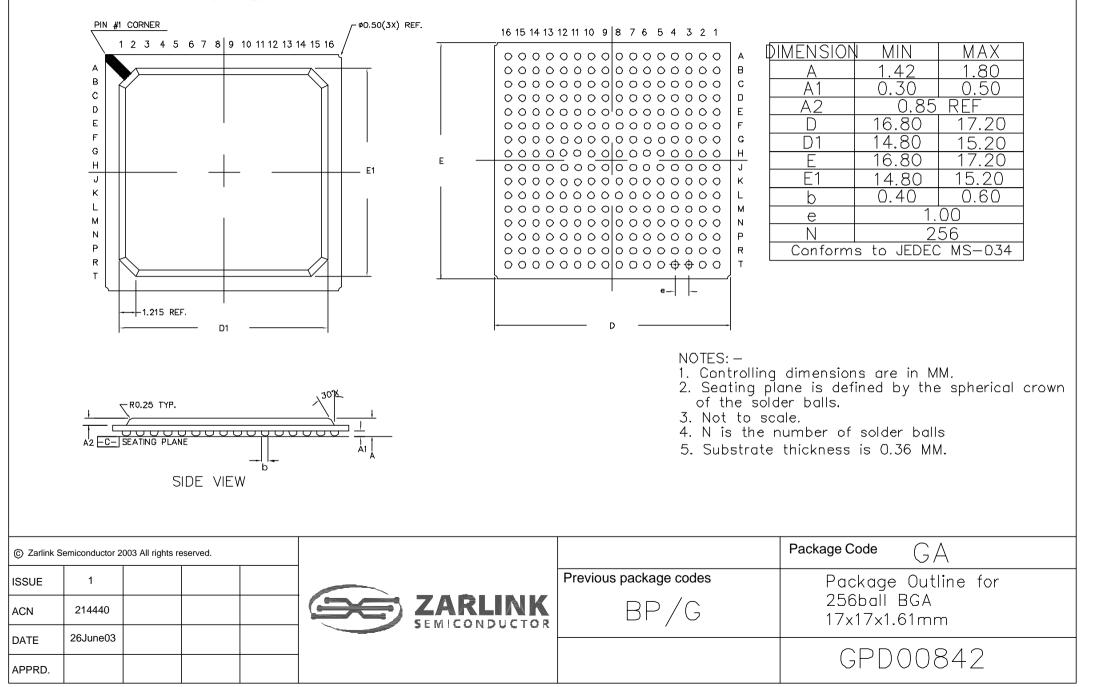
† Characteristics are over recommended operating conditions unless otherwise stated.

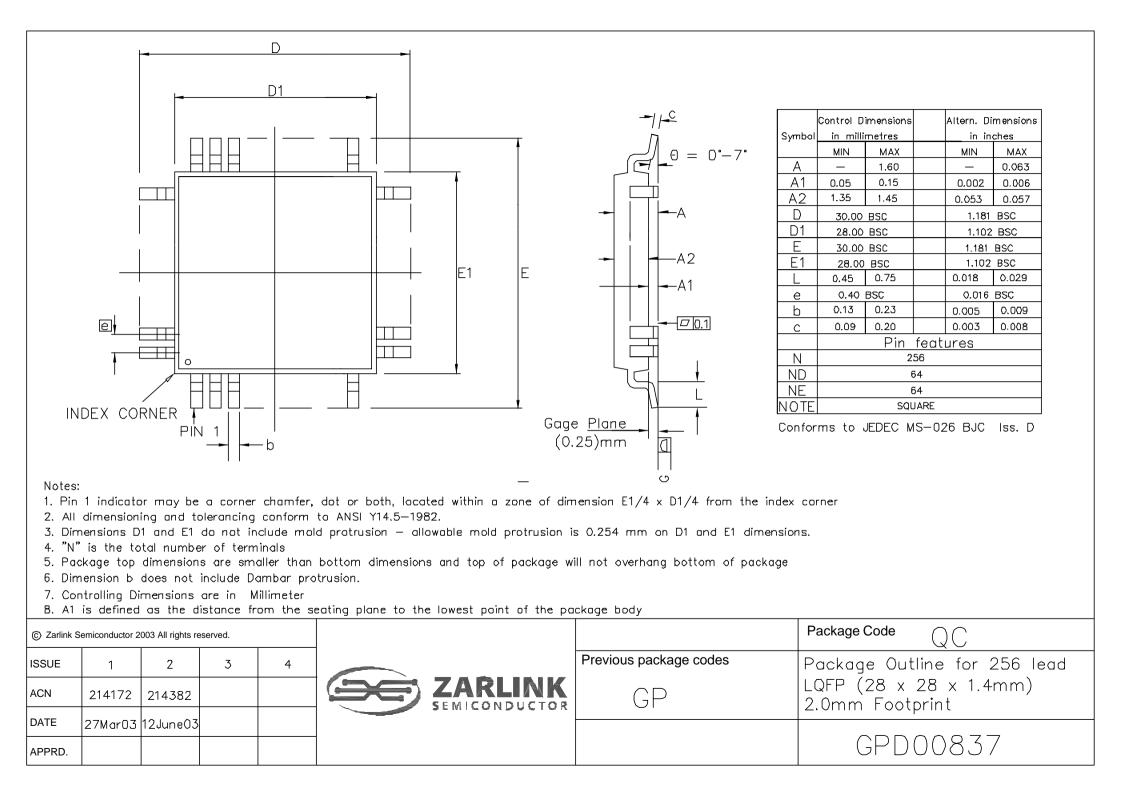


#### Figure 40 - Output Timing (ST-BUS Format)

TOP VIEW

#### BOTTOM VIEW







# For more information about all Zarlink products visit our Web Site at

#### www.zarlink.com

Information relating to products and services furnished herein by Zarlink Semiconductor Inc. or its subsidiaries (collectively "Zarlink") is believed to be reliable. However, Zarlink assumes no liability for errors that may appear in this publication, or for liability otherwise arising from the application or use of any such information, product or service or for any infringement of patents or other intellectual property rights owned by third parties which may result from such application or use. Neither the supply of such information or purchase of product or service conveys any license, either express or implied, under patents or other intellectual property rights owned by Zarlink or licensed from third parties by Zarlink, whatsoever. Purchasers of products are also hereby notified that the use of product in certain ways or in combination with Zarlink, or non-Zarlink furnished goods or services may infringe patents or other intellectual property rights owned by Zarlink.

This publication is issued to provide information only and (unless agreed by Zarlink in writing) may not be used, applied or reproduced for any purpose nor form part of any order or contract nor to be regarded as a representation relating to the products or services concerned. The products, their specifications, services and other information appearing in this publication are subject to change by Zarlink without notice. No warranty or guarantee express or implied is made regarding the capability, performance or suitability of any product or service. Information concerning possible methods of use is provided as a guide only and does not constitute any guarantee that such methods of use will be satisfactory in a specific piece of equipment. It is the user's responsibility to fully determine the performance and suitability of any equipment using such information and to ensure that any publication or data used is up to date and has not been superseded. Manufacturing does not necessarily include testing of all functions or parameters. These products are not suitable for use in any medical products whose failure to perform may result in significant injury or death to the user. All products and materials are sold and services provided subject to Zarlink's conditions of sale which are available on request.

Purchase of Zarlink's I<sup>2</sup>C components conveys a licence under the Philips I<sup>2</sup>C Patent rights to use these components in and I<sup>2</sup>C System, provided that the system conforms to the I<sup>2</sup>C Standard Specification as defined by Philips.

Zarlink, ZL and the Zarlink Semiconductor logo are trademarks of Zarlink Semiconductor Inc.

Copyright Zarlink Semiconductor Inc. All Rights Reserved.

TECHNICAL DOCUMENTATION - NOT FOR RESALE